

**MILLIMETER WAVE
NOISE MEASUREMENT
SYSTEMS USING
SOLID STATE
SOURCES**

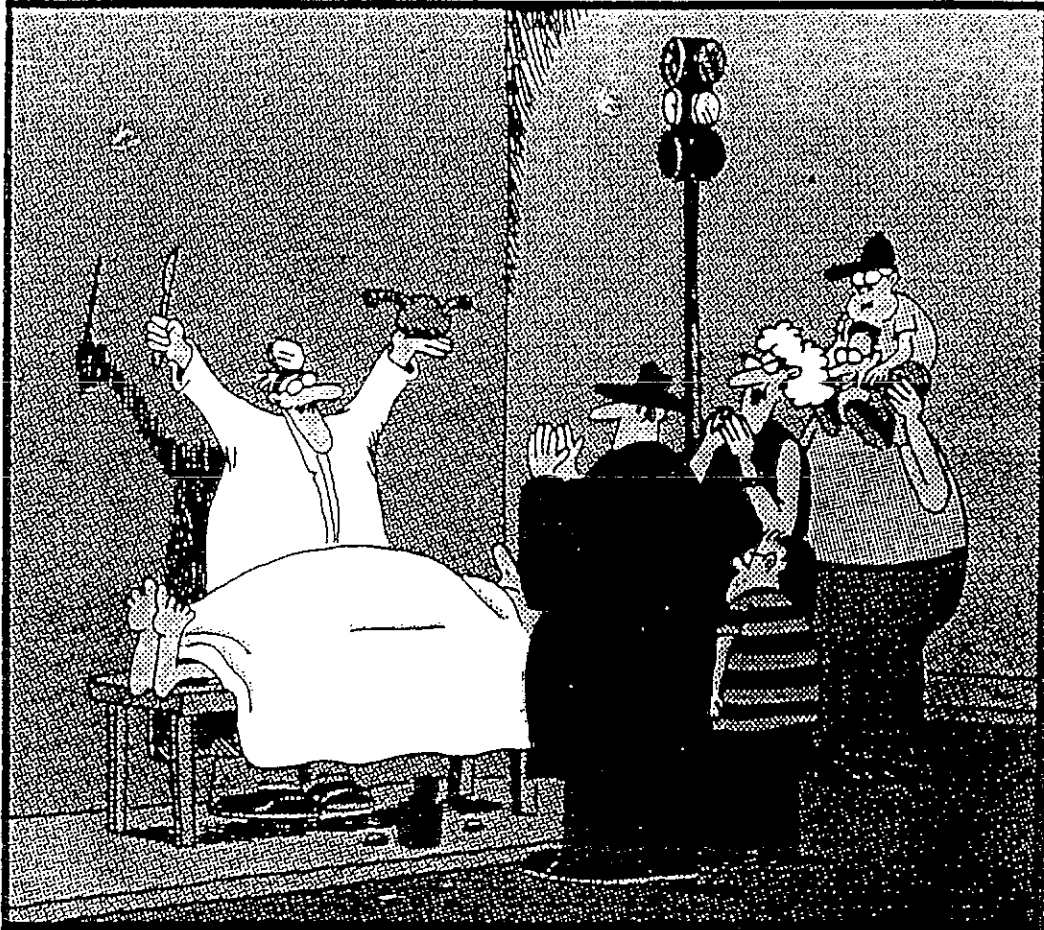
BY
DR. MATTHEW M. RADMANESH

ECE DEPT.,
CALIFORNIA STATE UNIVERSITY,
NORTHRIDGE

CONTENTS

- 1) IMPORTANCE OF NOISE
- 2) MILLIMETER WAVE NOISE MEASUREMENT --
A GENERAL SET-UP
- 3) NOISE GENERATORS (DESIGN OF SOLID
STATE SOURCES)
- 4) SPECIFIC MEASUREMENT SET-UPS
- 5) MEASUREMENT UNCERTAINTIES

CAUTION!

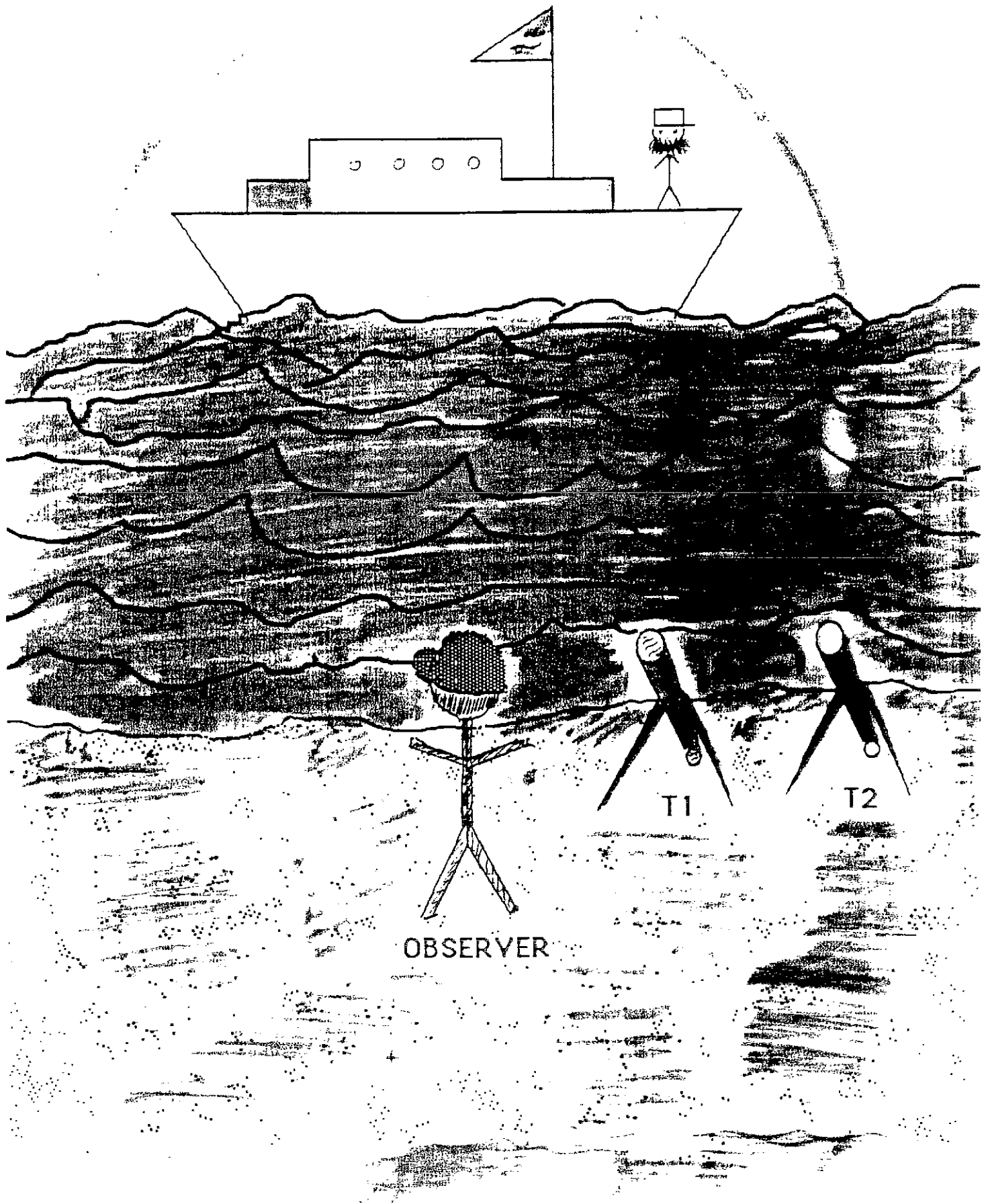


Street physicians

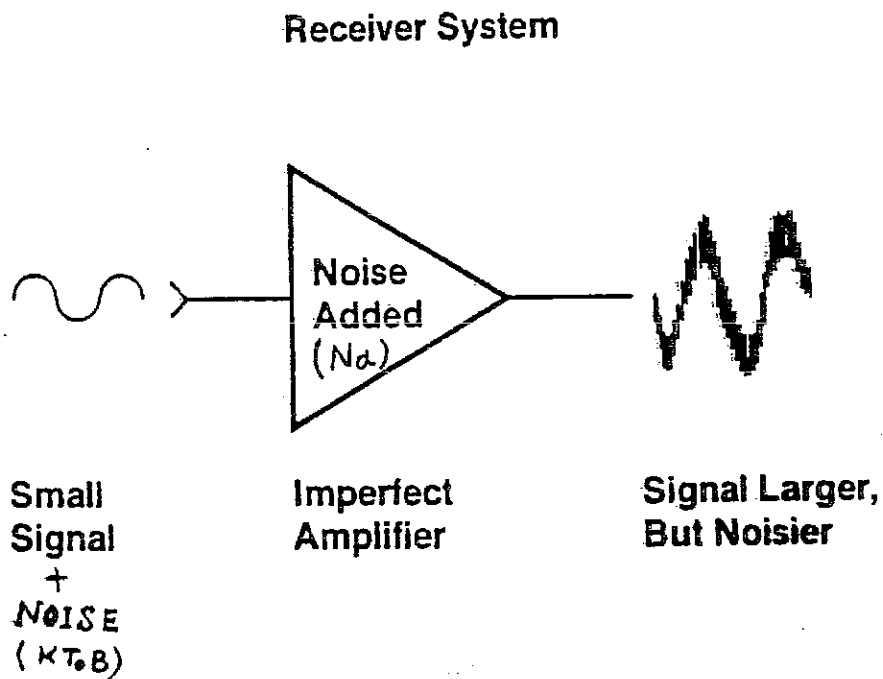
I) WHY NOISE IS IMPORTANT?

TO UNDERSTAND THE SIGNIFICANCE OF NOISE, LET'S FIRST DEFINE IT.

NOISE IS AN INTERNALLY GENERATED INTERFERENCE WHICH CAUSES THE CIRCUIT OPERATION TO BE DEGRADED FROM THEORETICAL PREDICTIONS.



SIMILARLY; AT THE FRONT END OF A RECEIVER:



- NOISE ADDED AT THE FRONT END OF AN RF/MW SYSTEM GREATLY INFLUENCES THE COST OF THE OVERALL SYSTEM

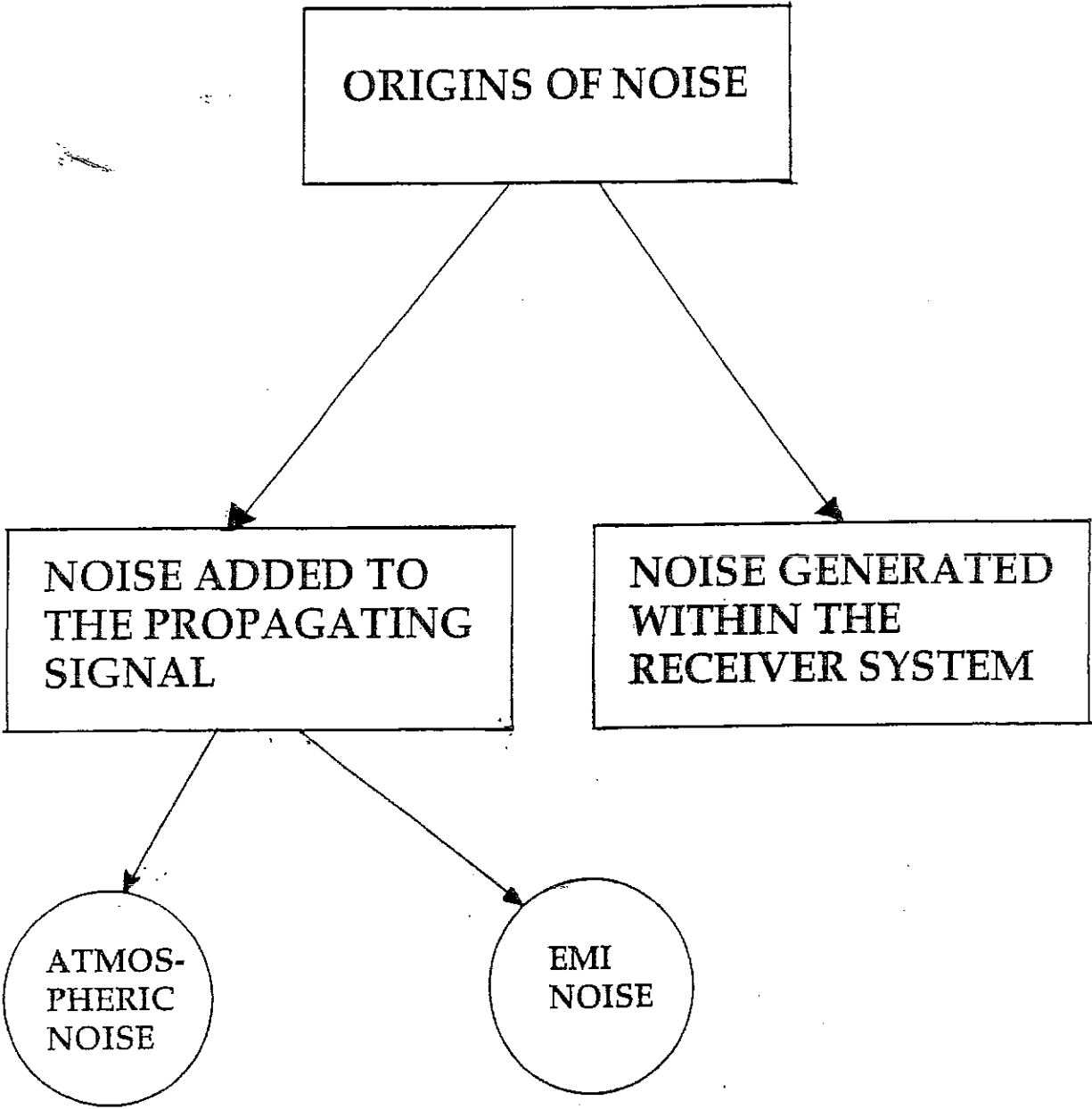
**NOISE REDUCTION
ALLOWS**

**WIDER
REPEATER
SPACING**

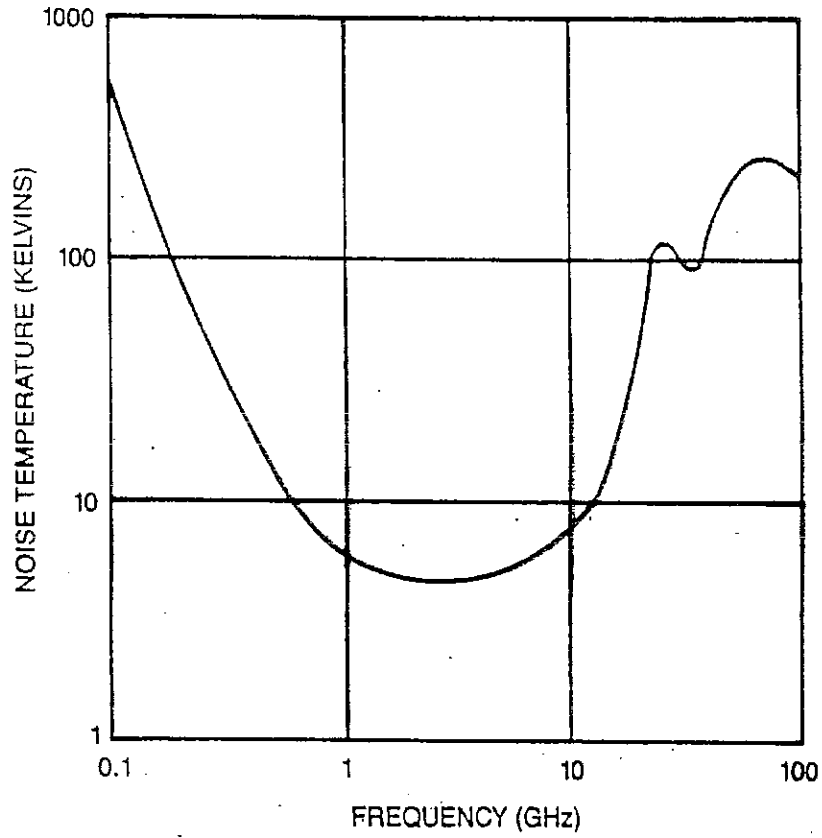
**LESS
TRANS-
MITTER
POWER**

**BETTER
SENSITIVITY
TO WEAK
SIGNALS**

**\$\$\$\$\$
HIGH ECONOMIC RETURN**



ATMOSPHERIC NOISE



**BATH-TUB GRAPH
PEAKING AROUND 61 & 94 GHz**

RECEIVER NOISE

**FROM
PASSIVE
COMPONENTS
& DEVICES**

**FROM ACTIVE
COMPONENTS
& DEVICES**

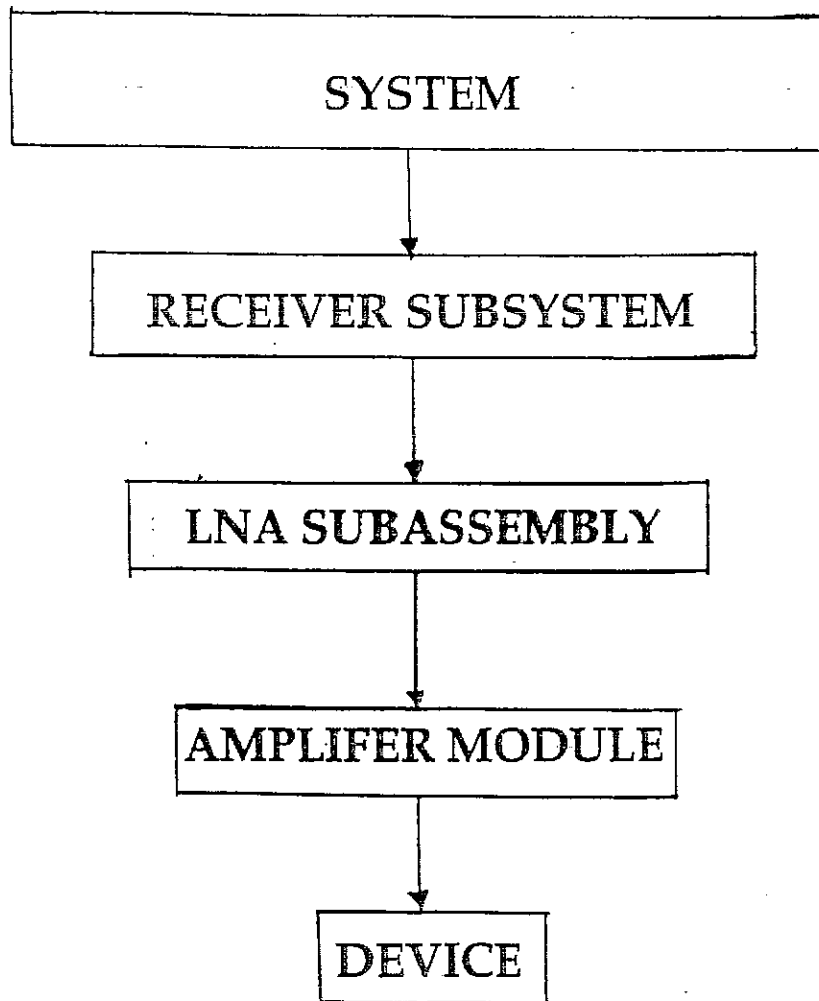
**DUE TO
THERMAL
NOISE**

**DUE TO
THERMAL
NOISE**

**DUE TO
SHOT
NOISE**

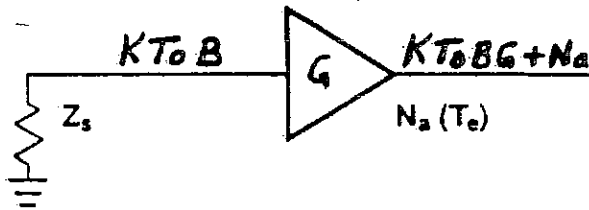
**DUE TO
FLICKER
NOISE OR
1/f NOISE**

- NF IS A COMMON LANGUAGE OF NOISE PERFORMANCE FOR ALL LEVELS:



II. NOISE MEASUREMENT

$$\text{NF} = \text{NOISE FIGURE} = \frac{(S/N)_i}{(S/N)_o} = 1 + N_a / K T_o B G$$



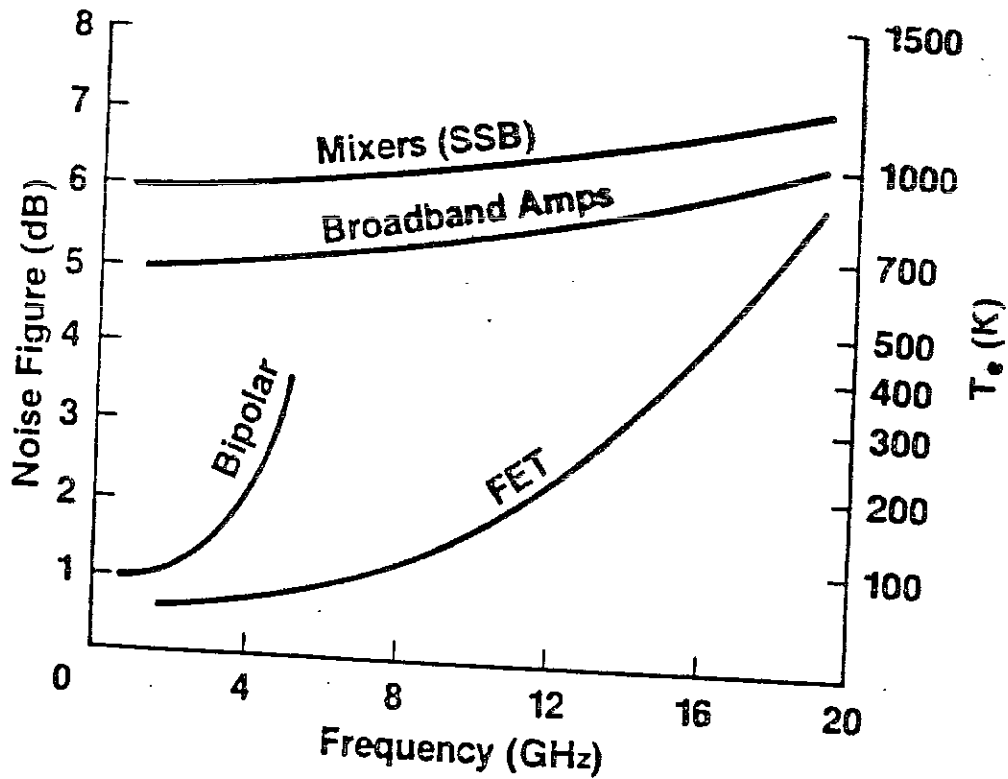
ALSO NF CAN BE WRITTEN AS:

$$NF = 1 + \frac{T_e}{T_o} \quad \left\{ \begin{array}{l} T_e = \text{Equiv. Noise Temp.} \\ T_o = 290^\circ \text{ k} \end{array} \right.$$

- NOISE FIGURE (NF) IS A FICTITIOUS FIGURE OF MERIT DESCRIBING THE NOISINESS OF A TRANSDUCER. IT DOES NOT TRULY EXIST IN THE SAME SENSE AS CURRENT AND VOLTAGE DO.

- NOISE FIGURE IS UNIQUE, PERMITTING NOISE PERFORMANCE SPEC. INDEP. OF OTHER PARAMETERS (SUCH AS GAIN, BW, ETC.)

STATE-OF-THE-ART NOISE FIGURES



EXAMPLE OF SYSTEM NOISE PERFORMANCE

SIGNAL:

Transmitter:	
ERP	+55 dBm
Path Losses	-200 dB
Rcvr. AnL Gain	60 dB
<hr/>	

Power to Receiver -85 dBm

NOISE:

Receiver:	
Noise Floor @ 290K	-174 dBm/Hz
Noise In 100 MHz BW	+80 dB
Receiver N.F.	+5 dB
<hr/>	

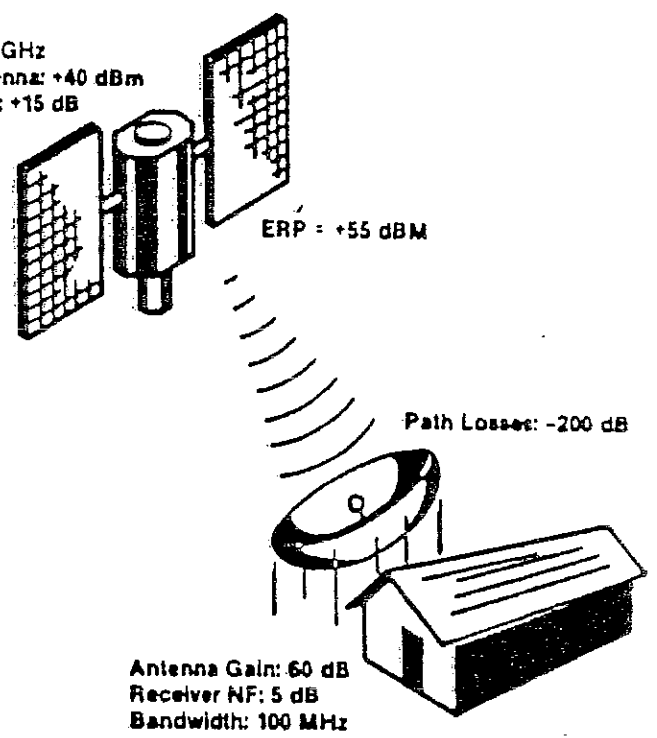
Receiver Sensitivity -89 dBm

Link Margin: 4 dB

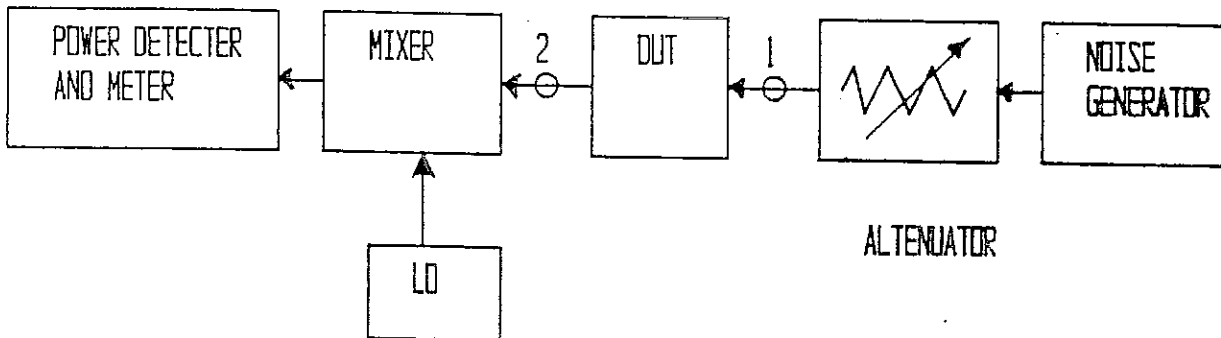
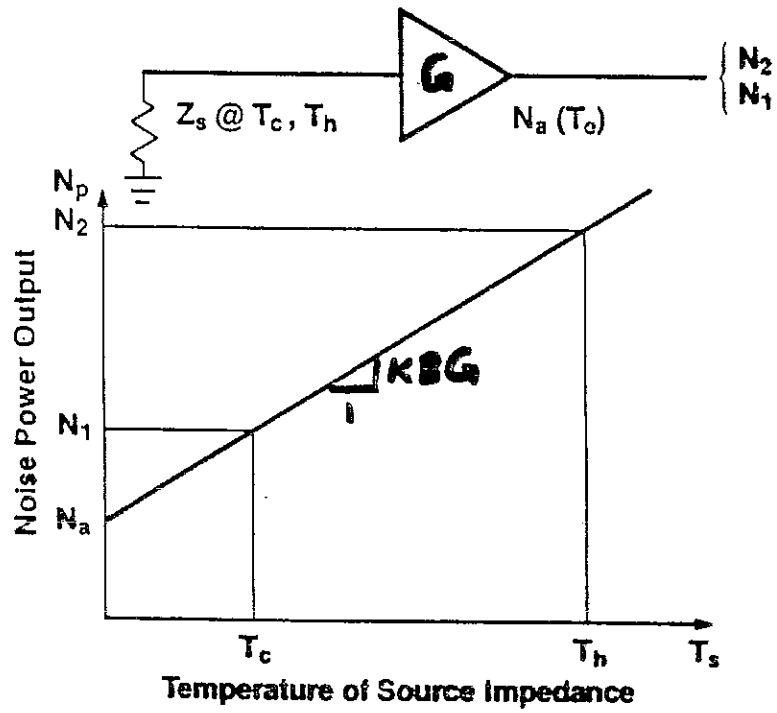
Increase Margin by 3 dB

1. Double transmitter power
2. Increase size of antennas by 3 dB
3. Lower the receiver N.F. by 3 dB

Frequency: 12GHz
 Power to Antenna: +40 dBm
 Antenna Gain: +15 dB



A BASIC MEASUREMENT SET-UP



NOISE GENERATORS

```
graph TD; A[NOISE GENERATORS] --> B[THERMAL NOISE SOURCES (OR HOT/ COLD STANDARDS)]; A --> C[GAS-DISCHARGE NOISE TUBES]; A --> D[SOLID STATE NOISE SOURCES]; B --> E[VERY ACCURATE ACCURACY: ± 0.1dB]; C --> F["- HIGH TEMP.  
- WHITE NOISE  
- NEEDS MODULATOR  
- ENR ≈ 15 dB"]; D --> G["- V.HIGH O/P ENR  
- LOW ON/OFF VSWR  
- LOW MIS-MATCH ERROR  
- USES IMPATT'S"];
```

THERMAL
NOISE
SOURCES
(OR HOT/
COLD
STANDARDS)

VERY ACCURATE
ACCURACY: $\pm 0.1\text{dB}$

GAS-
DISCHARGE
NOISE
TUBES

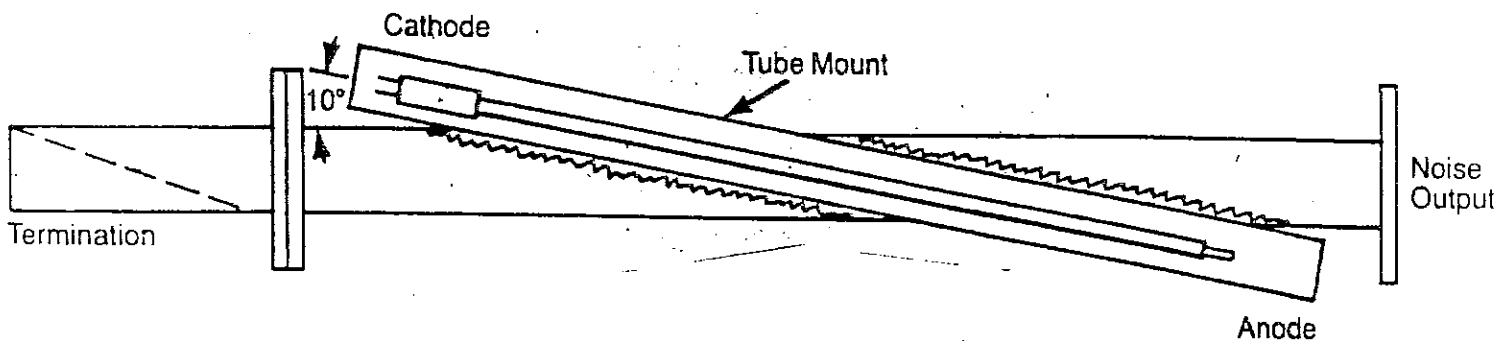
- HIGH TEMP.
- WHITE NOISE
- NEEDS MODULATOR
- ENR $\approx 15\text{ dB}$

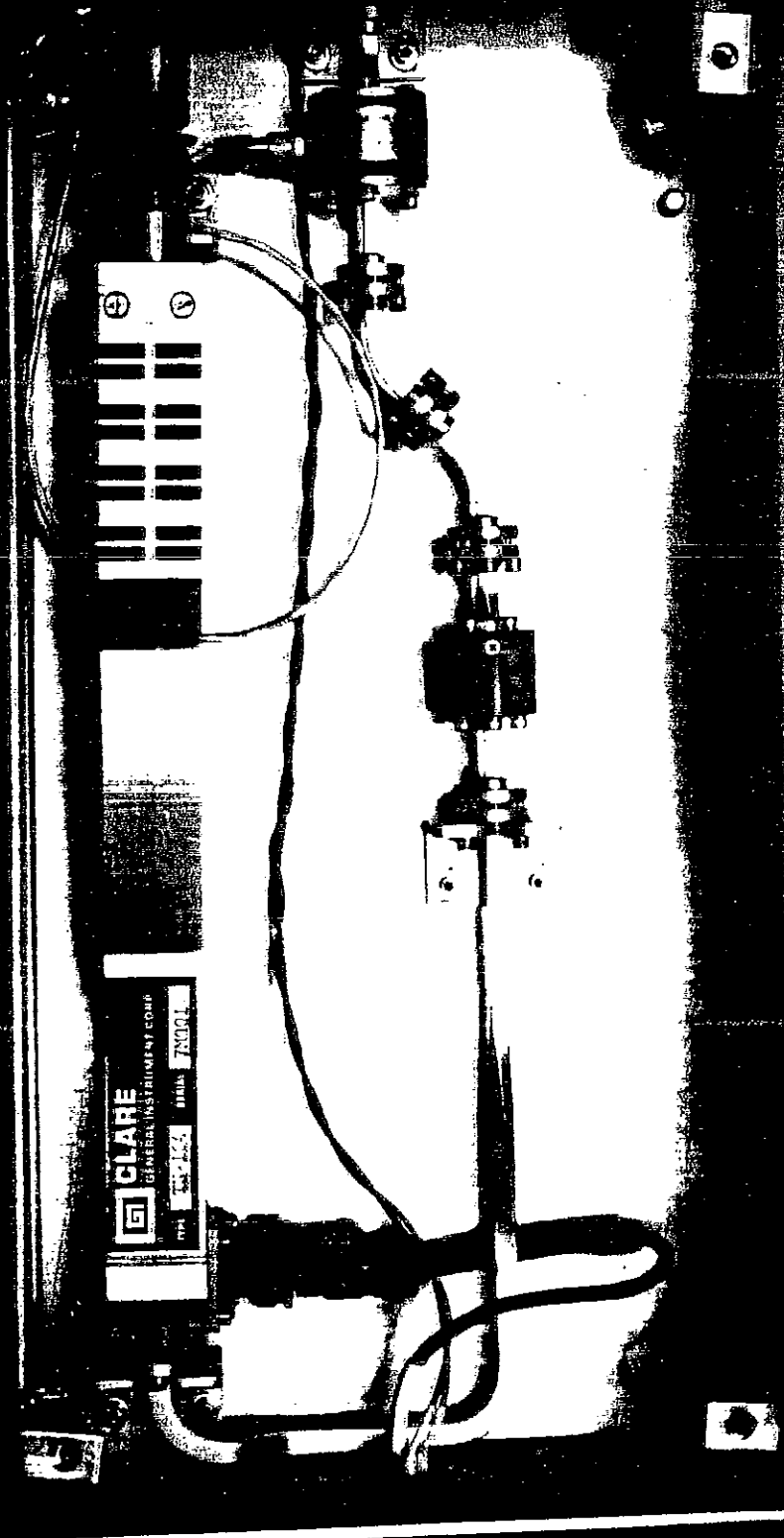
SOLID
STATE
NOISE
SOURCES

- V.HIGH O/P ENR
- LOW ON/OFF VSWR
- LOW MIS-MATCH ERROR
- USES IMPATT'S

A Waveguide Gas-Discharge Noise Tube

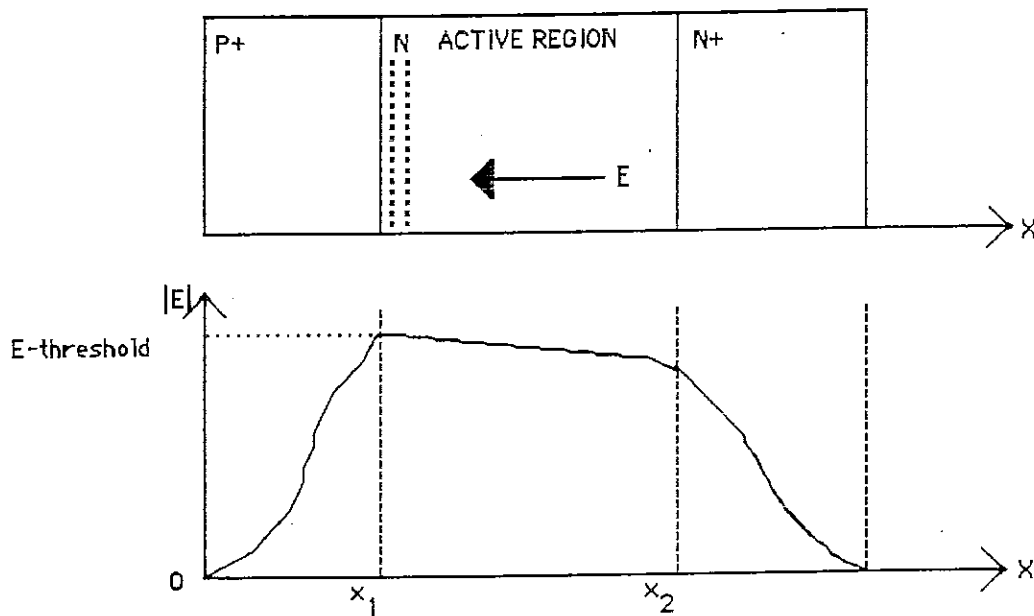
- Waveguide Gas-Discharge
 - Stable with Power Source
 - Flat with Frequency
 - Significant Mismatch Change On to Off
 - High Voltage Power Supply Required
 - Cold Termination Heating





SOLID STATE NOISE SOURCES

8. **IMPATT Diode** (Impact Avalanche and Transit Time): a Pn junction diode with a depletion region adjacent to the junction (for carrier drift). The diode is biased to be in Avalanche breakdown.



II. NOISE THEORY

Noise Power Spectral Density Function for an IMPATT:

$$W(f) = a^2 (V_b/I) (R_L/[R_{sc} + R_{sp} + R_L]^2) / (1 - f^2/f_a^2)^2$$

where:

$$f_a = [7.6I/(AV_b)]^{1/2}$$

Assumptions:

1. small transit angle
2. no external reactive element

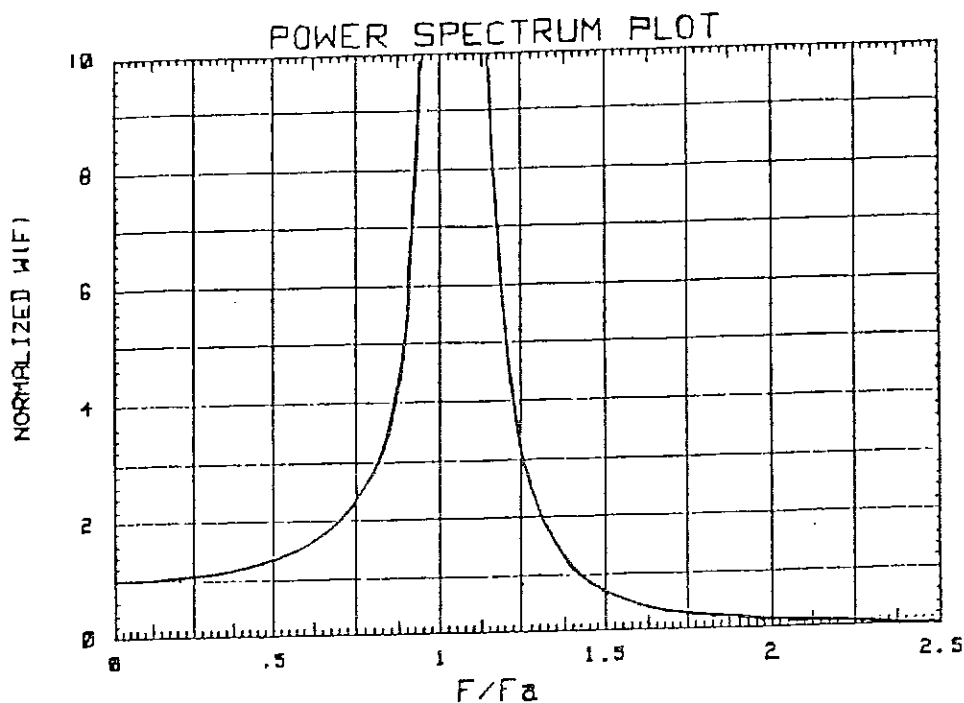


Fig. 1: Plot of $W(f)$ versus f/f_a .

IV. MICROWAVE AND MILLIMETER WAVE IMPATT DIODES

A-Assembly and proper packaging of IMPATTs:

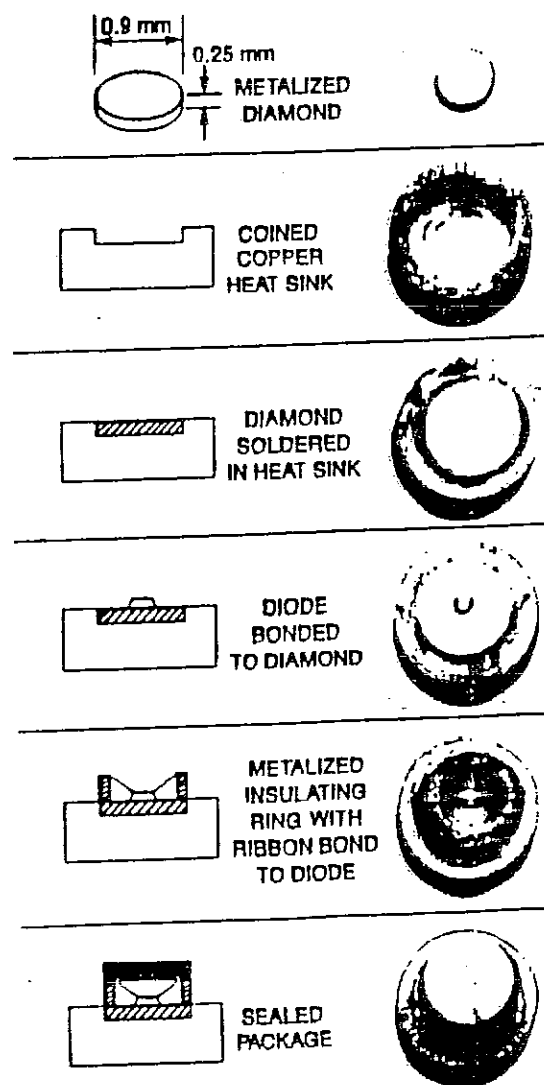


Fig. 3a : Assembly and proper packaging of millimeter-wave diodes.

C - Variation of total package inductance versus the number of radial connections

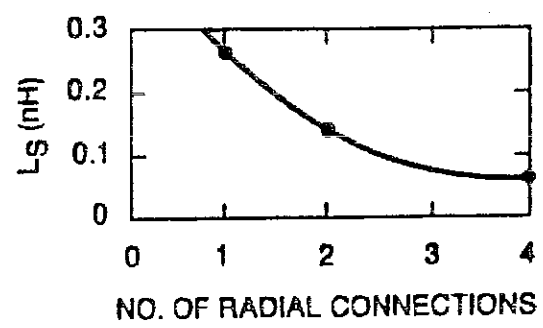
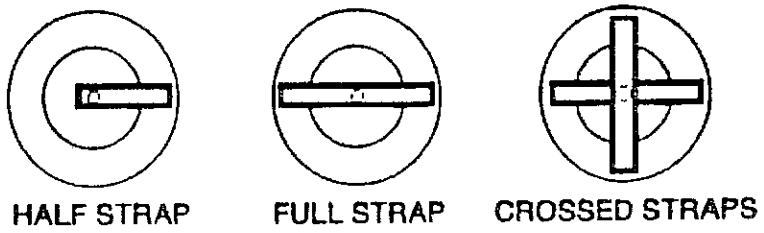


Fig.3c : Variation of total package inductance versus the number of radial connections.

B- Cross section of the final package for a half-strap IMPATT diode.

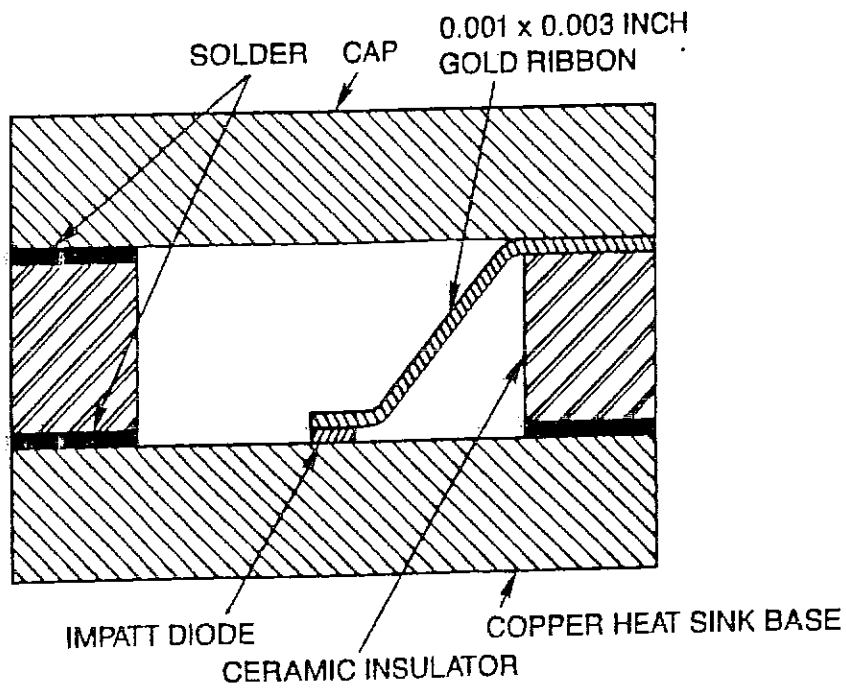
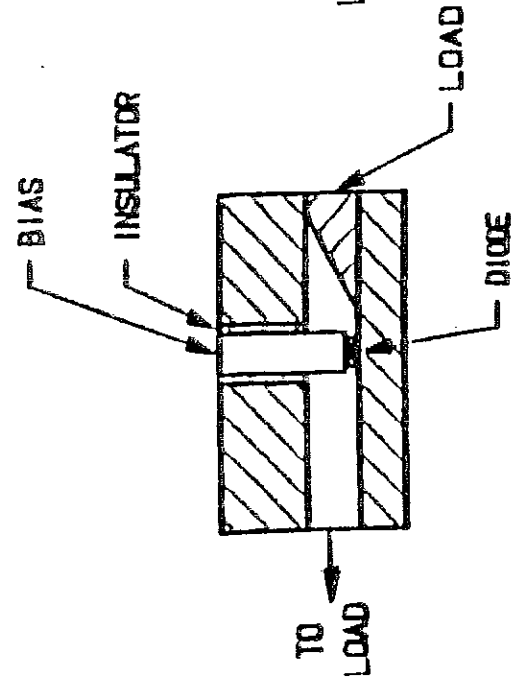
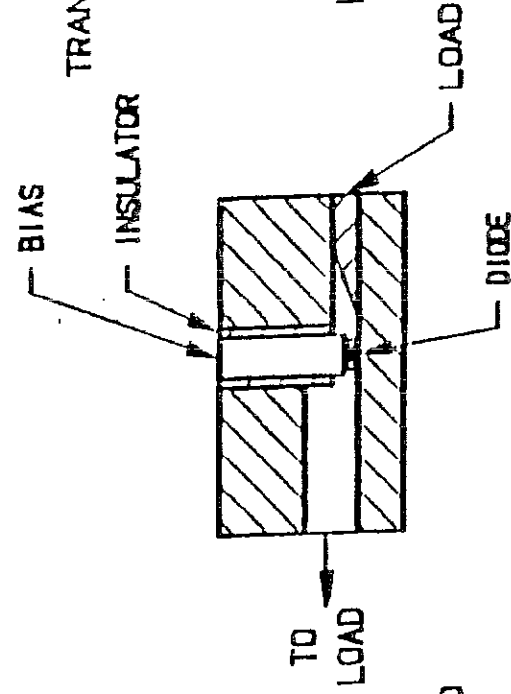


Fig. 3b : Cross section of the final package for a half-strap diode.

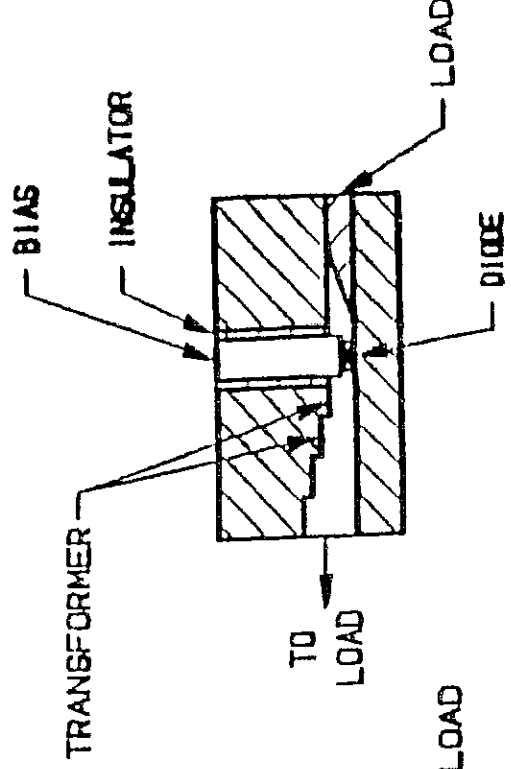
III. WAVEGUIDE CAVITY MOUNTED IMPATT NOISE-SOURCE CONFIGURATIONS



A) FH-FH W/LOAD



B) FH-RH W/LOAD



C) RH-RH W/LOAD

FIG. 2: WAVEGUIDE CONFIGURATIONS

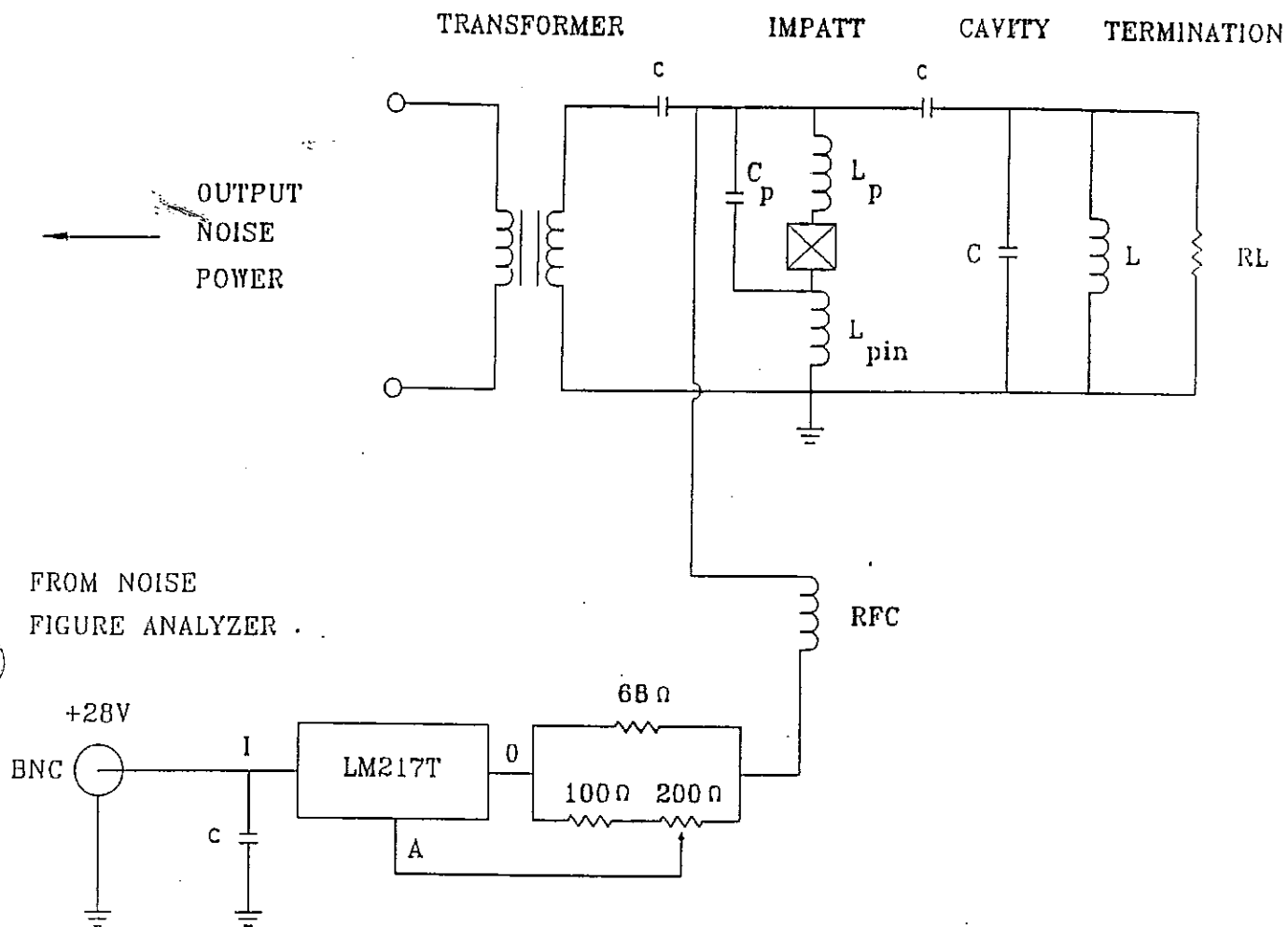


Fig. 3e: noise source equivalent circuit

- 1 DC current regulator
- 2 Regulator printed circuit board
- 3 Side cover
- 4 IMPATT cavity housing
- 5 Spring mechanism
- 6 V-band integral flange

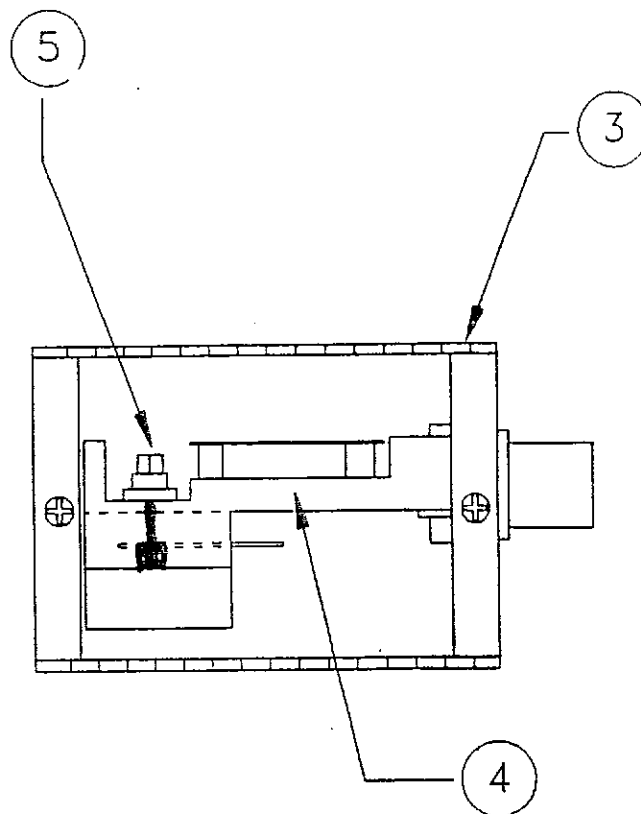
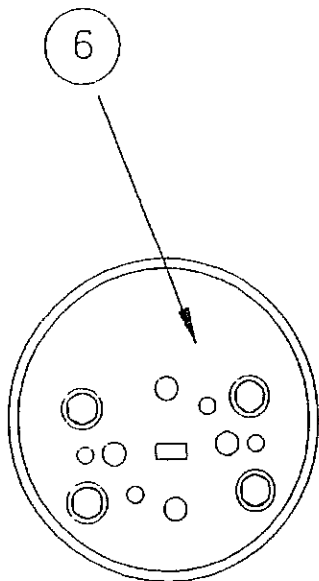
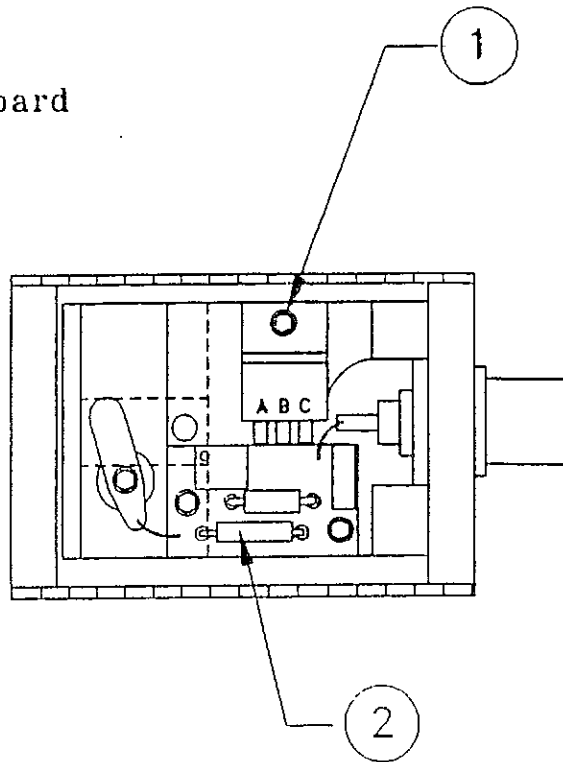


Fig 3d: Prototype of the V-band noise source with build-in DC current regulator.

VII - CONCLUSIONS

MAIN CHARACTERISTICS AND IMPORTANT ADVANTAGES:

- 1 - Large B.W.
- 2 - Large Operating Temperature Range
- 3 - Higher Noise Output
- 4 - Lower power consumption
- 5 - Pulsed Operation (sub-nsec)
- 6 - Higher Reliability
- 7 - Variable Noise Output-ENR 5 to 30 dB
- 8 - Smaller size and lower weight
- 9 - Full Waveguide Bands (26.5 to 110 GHz)
- 10 - Internal Modulator/Output matching
(VSWR<1.2)

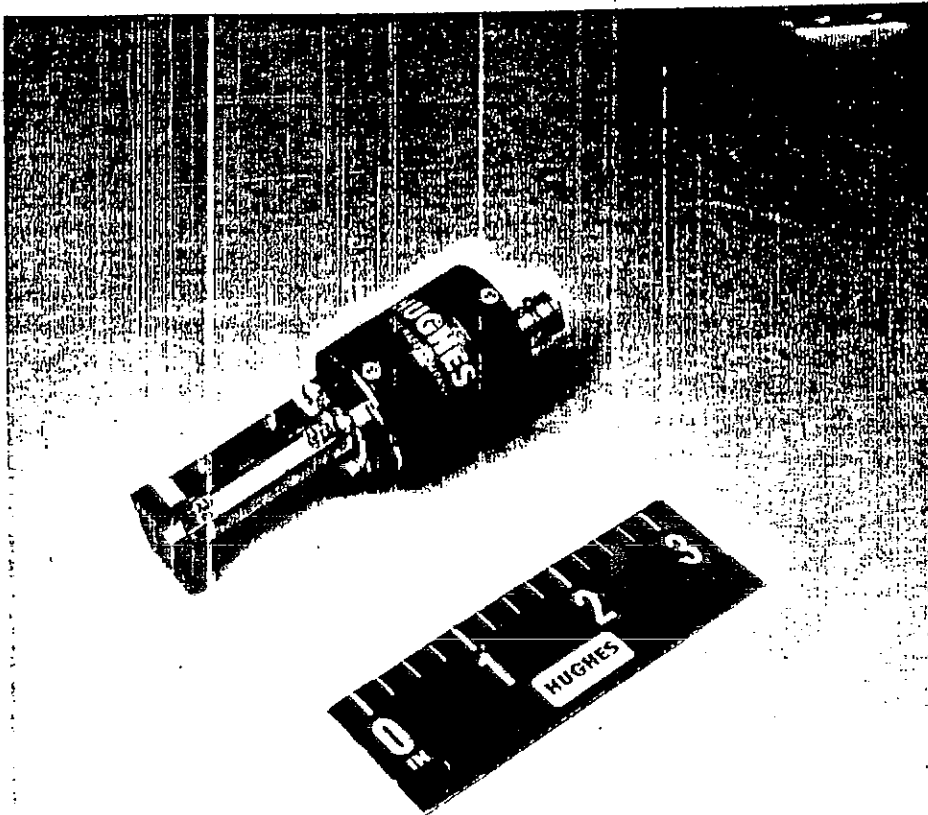


PHOTO OF THE NEWLY DEVELOPED SOLID STATE NOISE SOURCE

VI. EXPERIMENTAL RESULTS

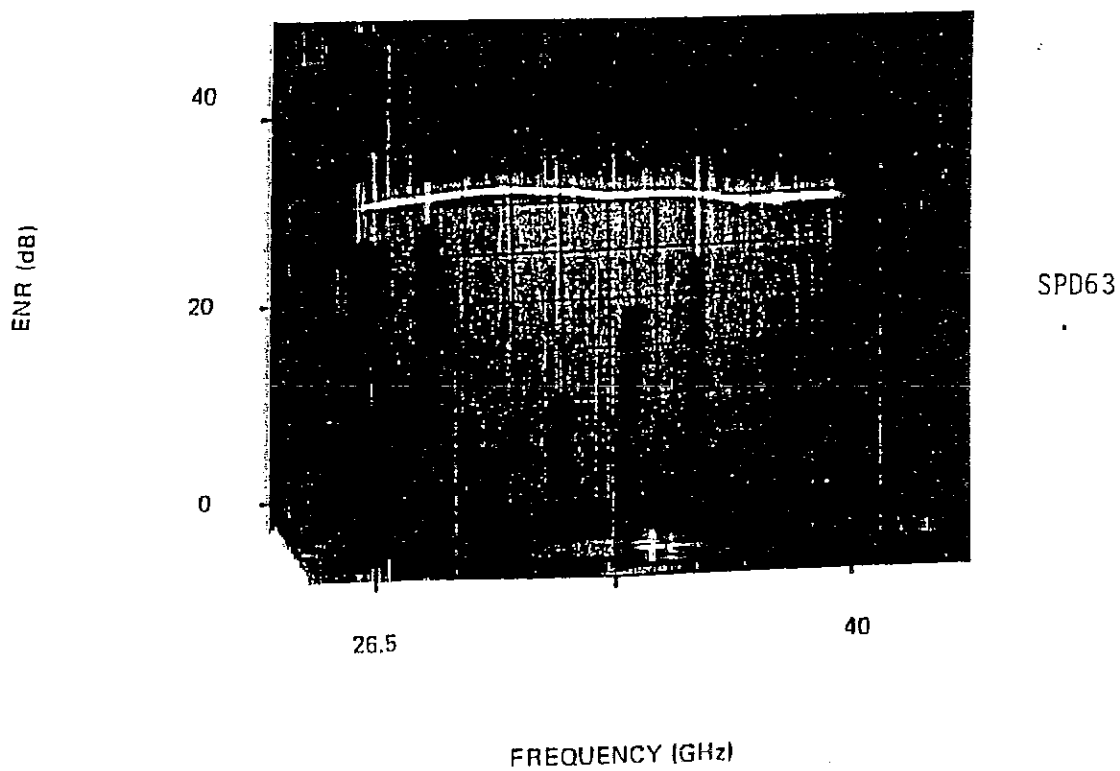


Fig. 7: Photograph of ENR plot in the Ka-Band using a 120 GHz in a RH-RH waveguide cavity mount.

VI. EXPERIMENTAL RESULTS

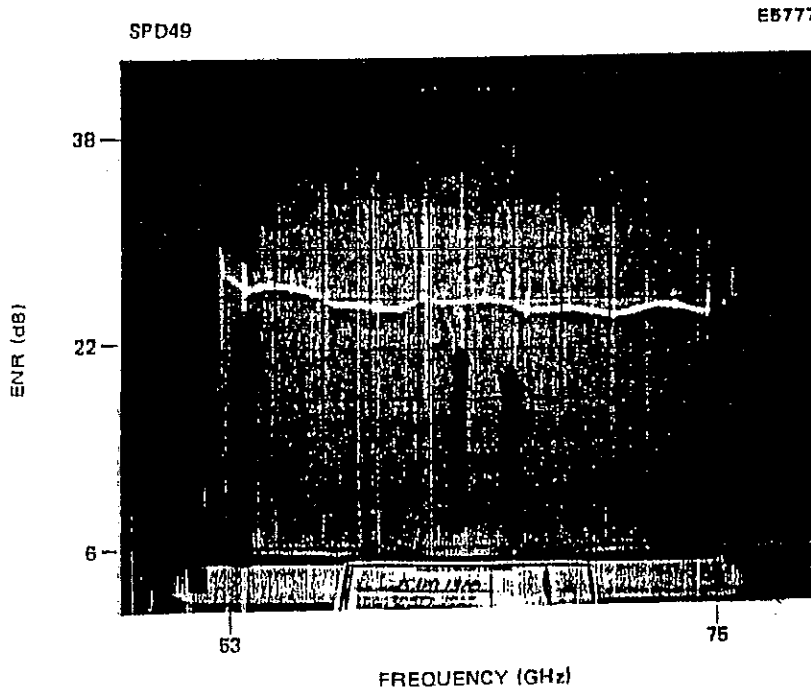


Figure 11 Photograph of ENR plot over the V-band in an RH-RH cavity mount ($I_{DC} = 40$ mA).

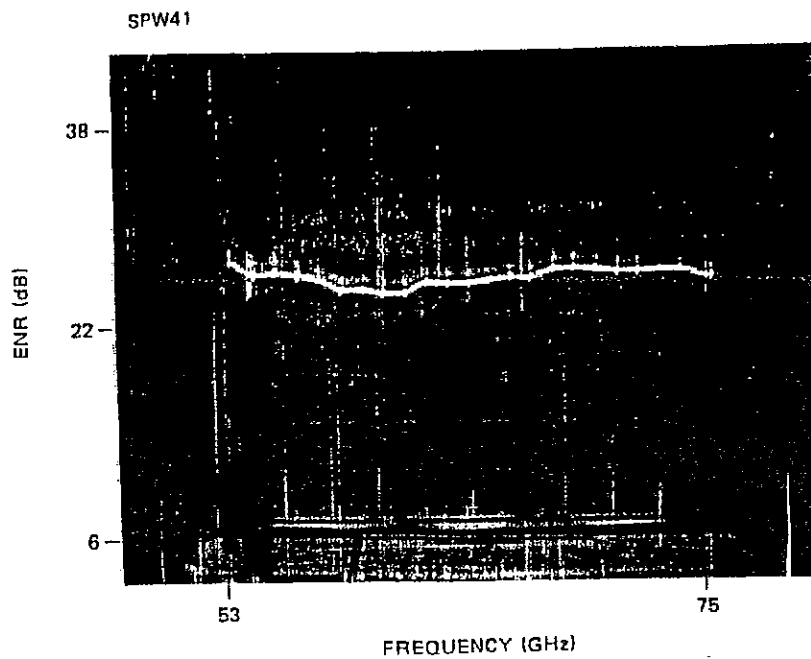


Figure 12 Photograph of ENR plot over the V-band in an RH-RH cavity mount ($I_{DC} = 40$ mA).

VI. EXPERIMENTAL RESULTS

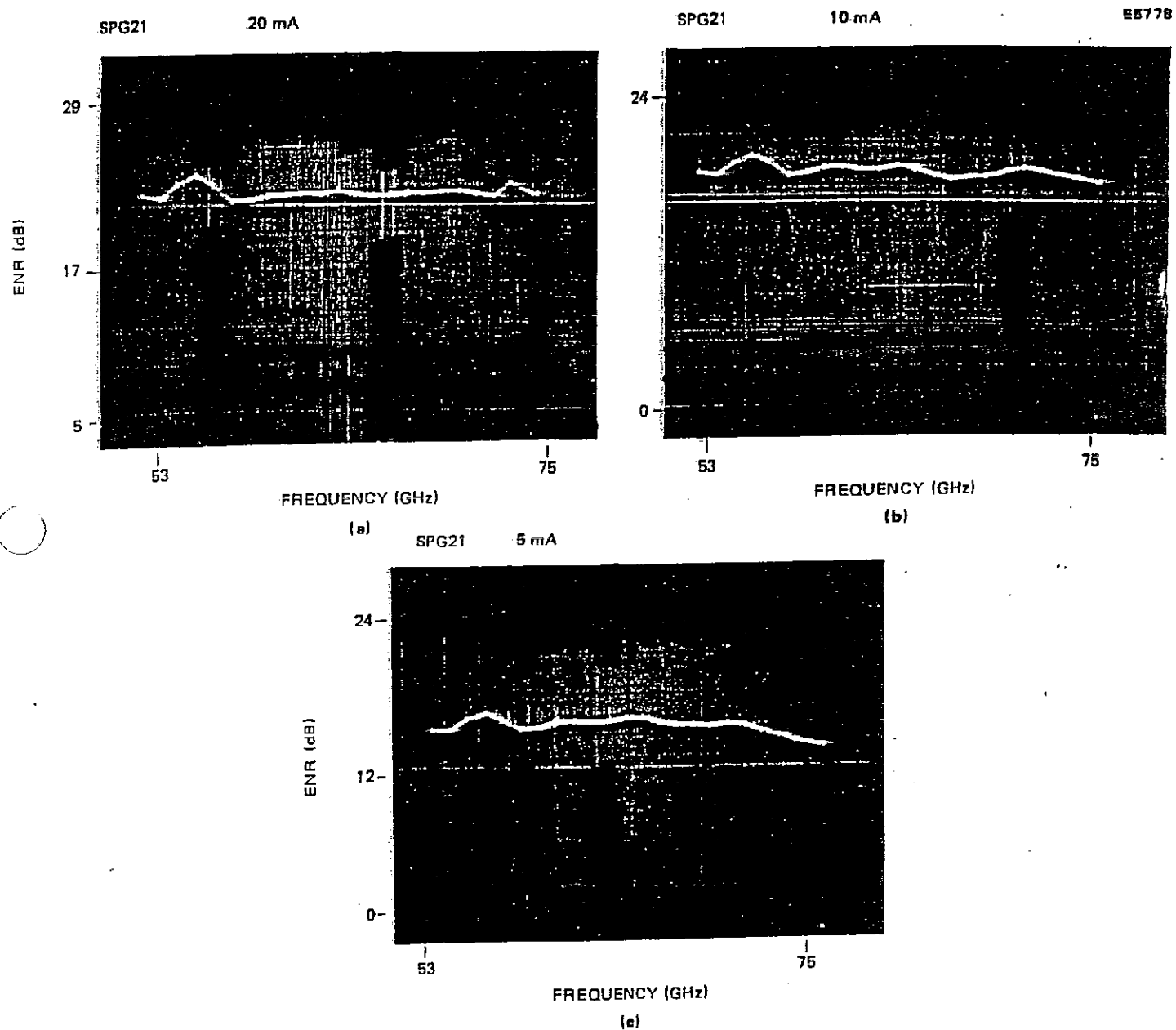
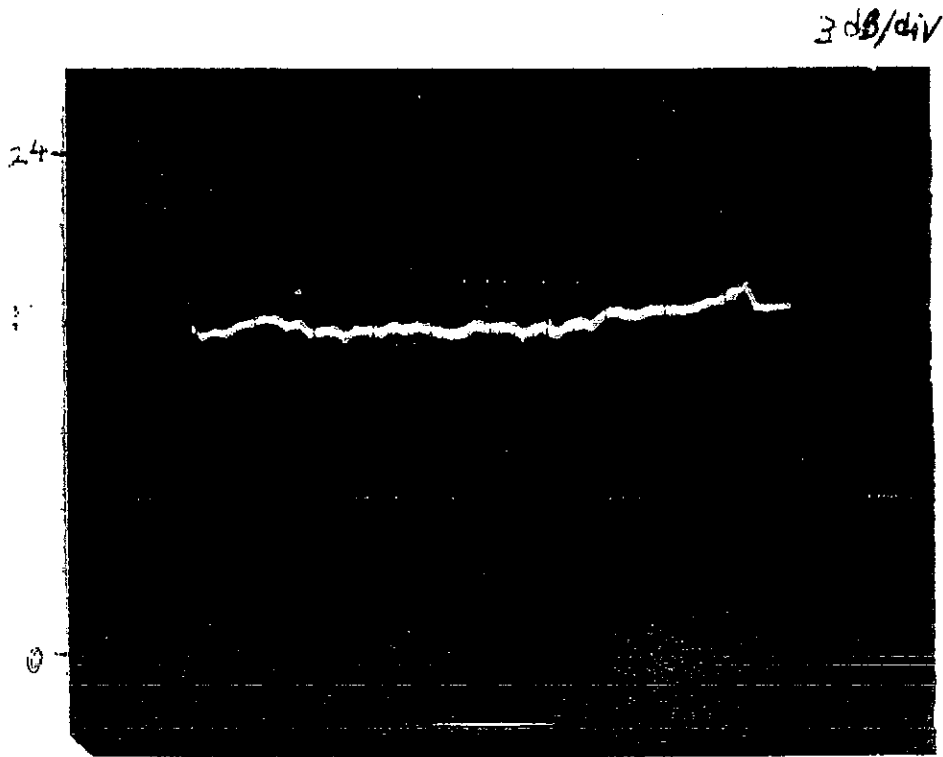


Figure 10 Photograph of ENR plot in the V-band in an RH-RH waveguide cavity mount ($I_{DC} = 20, 10, 5$ mA).



ENR of the noise Tube (50-75)

ENR PLOT OF THE NOISE TUBE (VERT: 3 dB/DIV ; HORZ: 50-75 GHZ)

IV. Measurement setups

```
graph TD; A[IV. Measurement setups] --> B[Manual noise measurement]; A --> C[Automatic noise measurement]; B --> D["-Calculation at each freq.  
-tedious for multiple meas."]; C --> E["- NF is a display readout  
- lends itself to multiple meas."];
```

Manual
noise
measurement

- Calculation at each freq.
- tedious for multiple meas.

Automatic
noise
measurement

- NF is a display readout
- lends itself to multiple meas.

Manual measurement

Noise measurement setup #1

In general: $NF = ENR - 10 \log (N_2/N_1 - 1)$

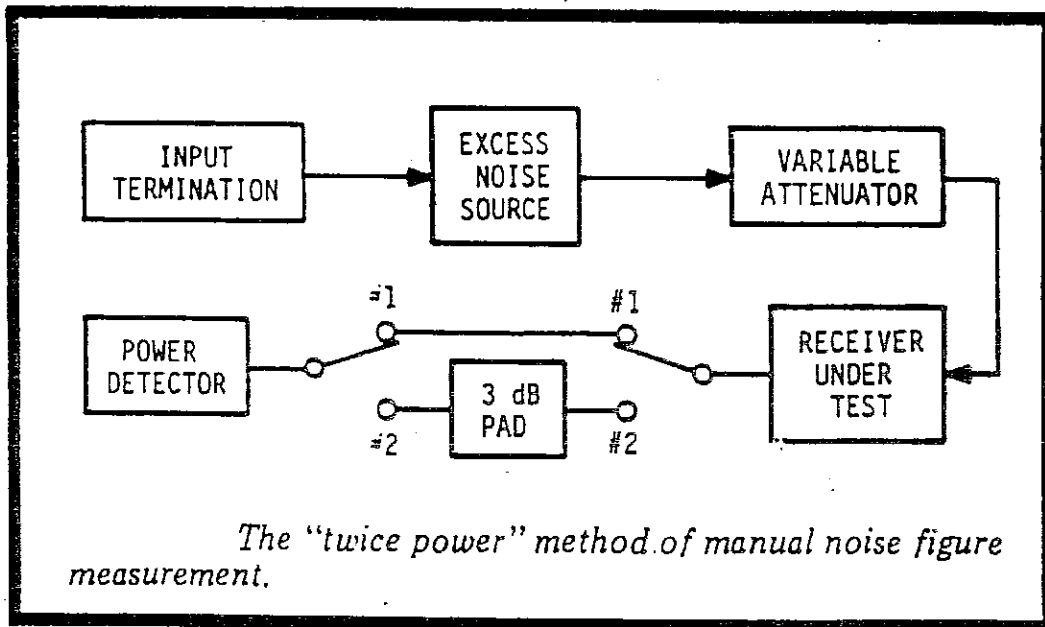
$$ENR = 10 \log \frac{T_N - T_0}{T_0}$$

T_N = equivalent noise temp.

$T_0 = 290^\circ K$

Manual measurement: twice-power method

NF = attenuated excess noise ratio



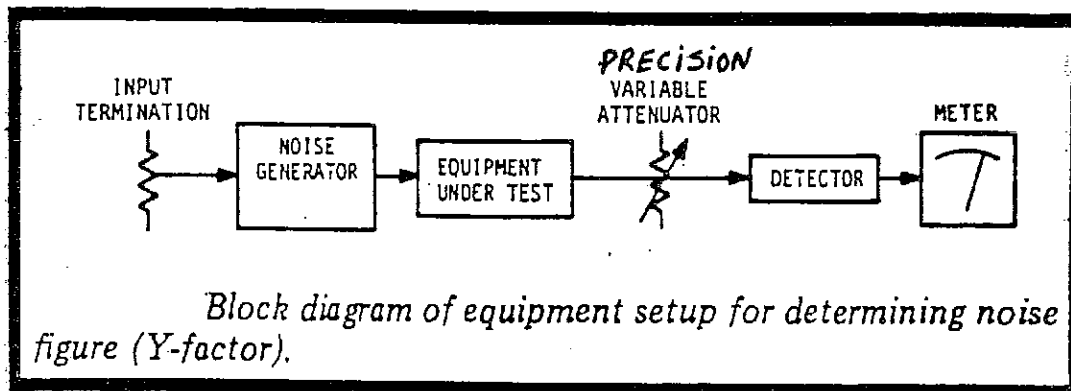
Noise measurement setup # 2

- A more popular method for manual measurement: y - Factor method

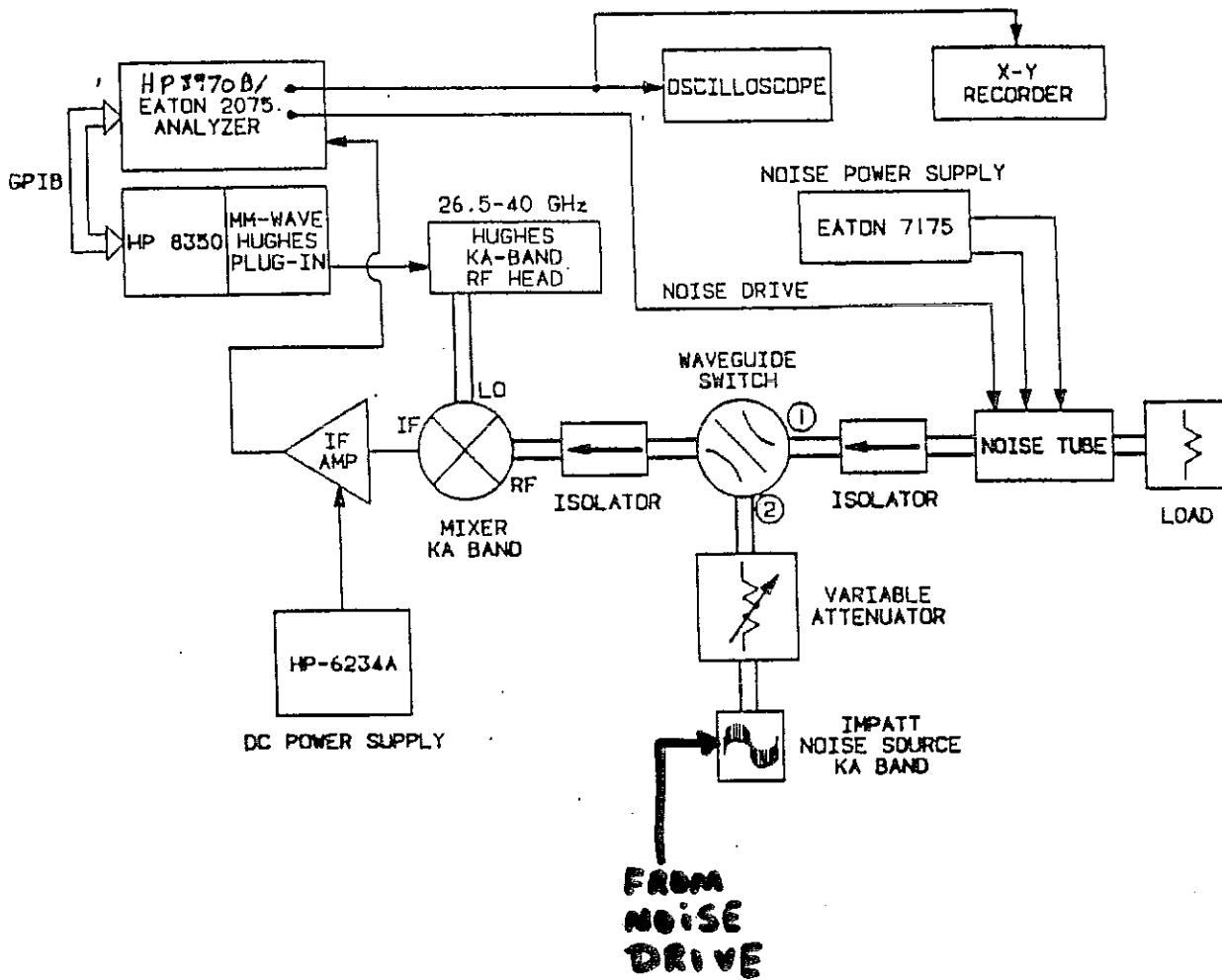
1. Noise source off N_1
2. Noise source on N_2

$$NF_{dB} = ENR - 10 \log \left(\frac{N_2}{N_1} - 1 \right)$$

$$Y = N_2/N_1$$

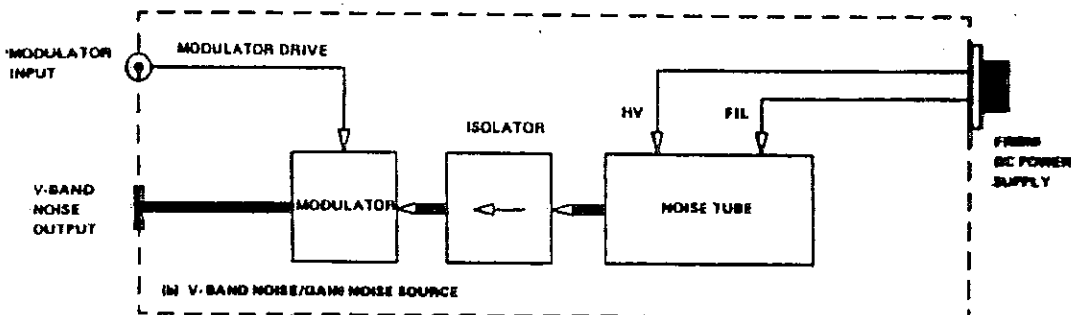
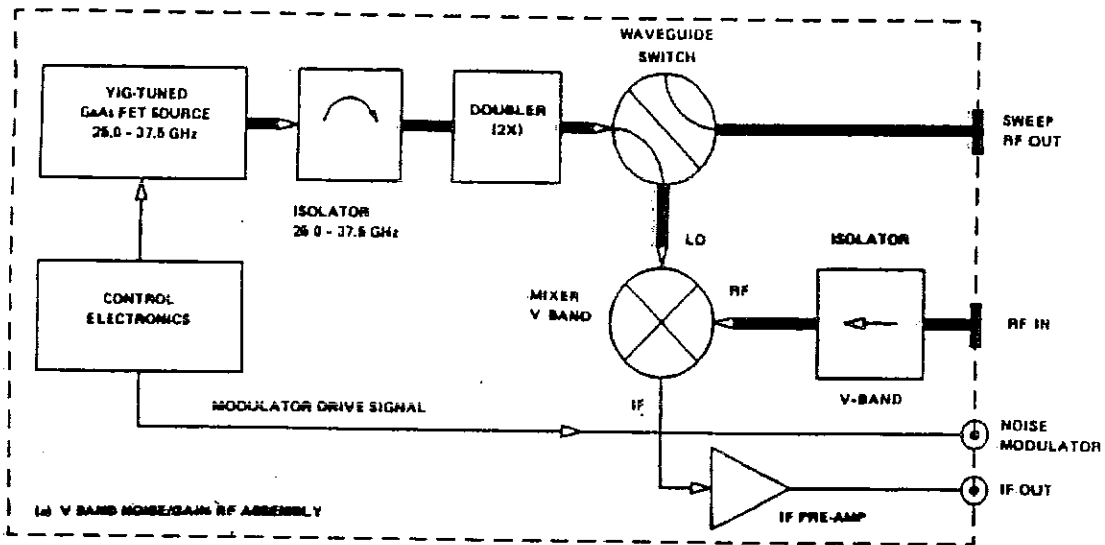


AUTOMATIC NOISE MEASUREMENT



Automatic Noise measurement

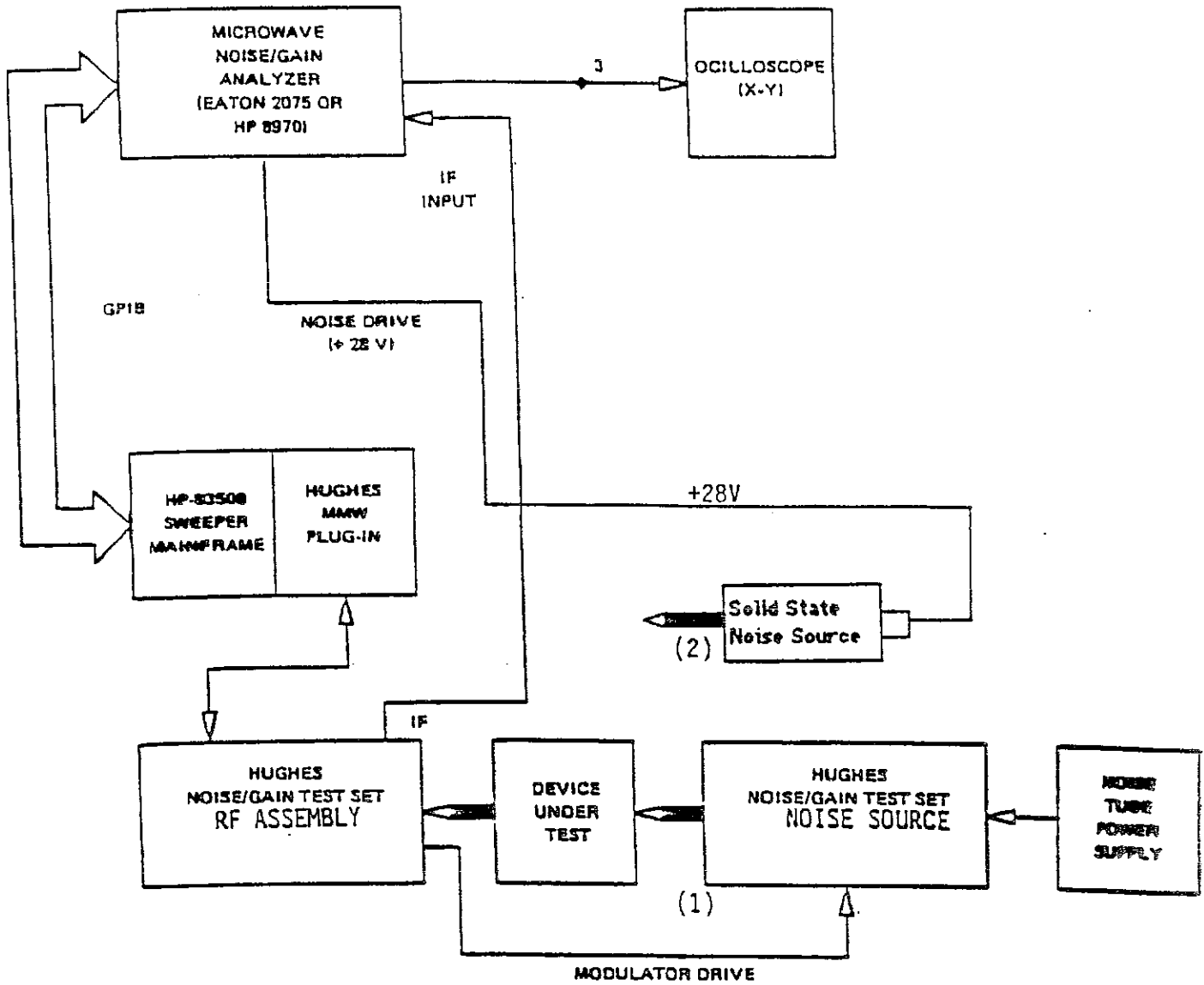
Modular approach



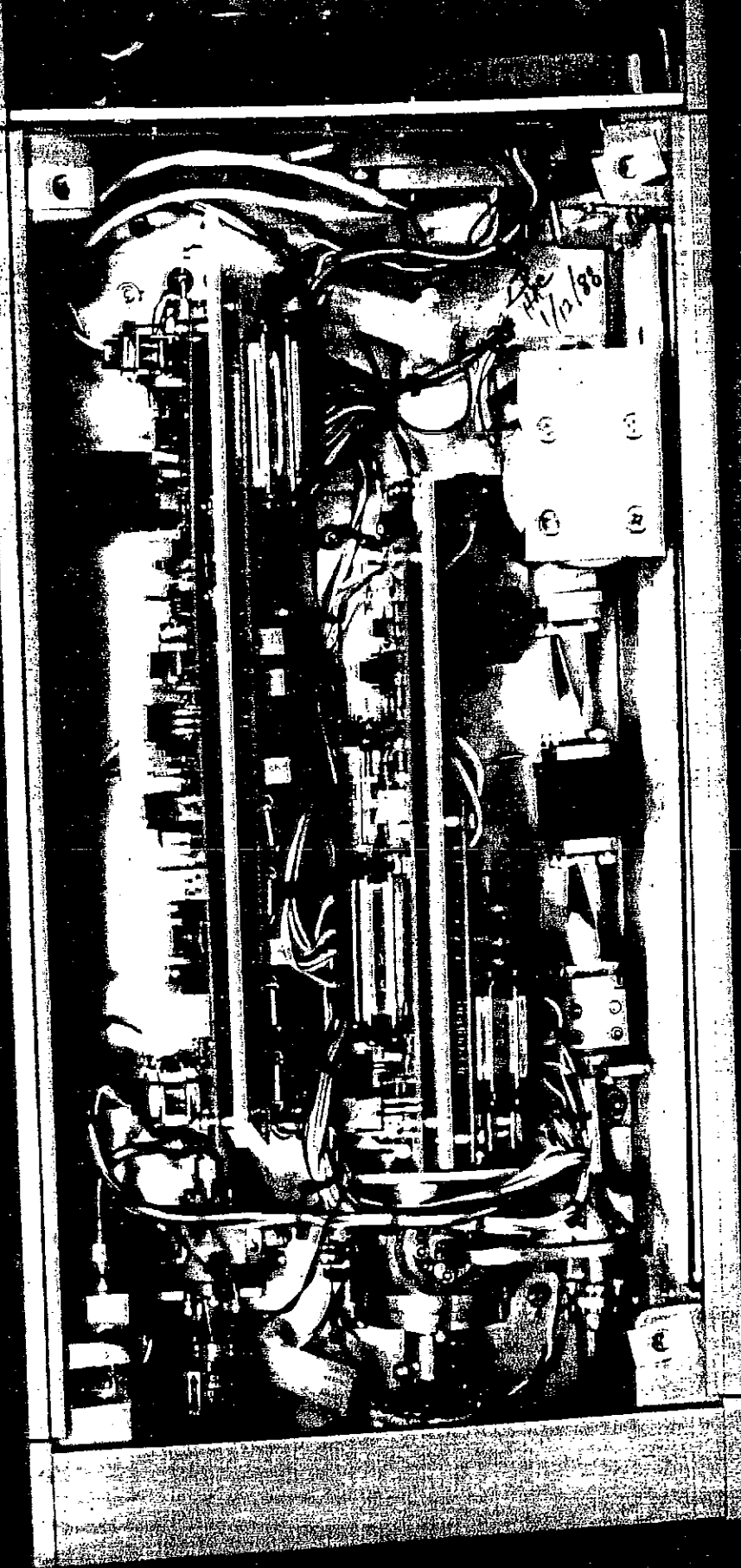
noise/gain test set RF assembly and noise source

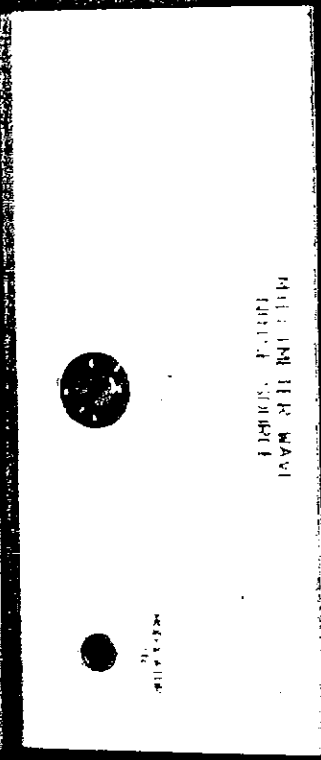
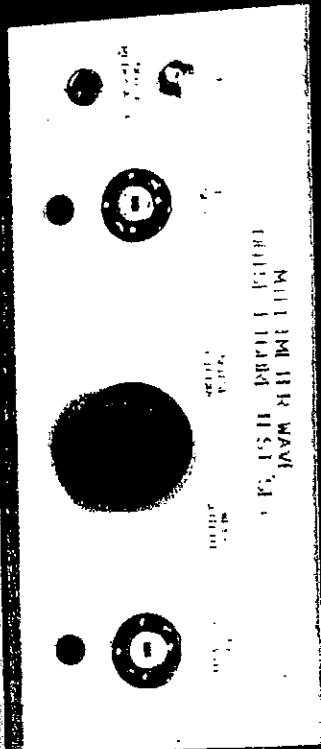
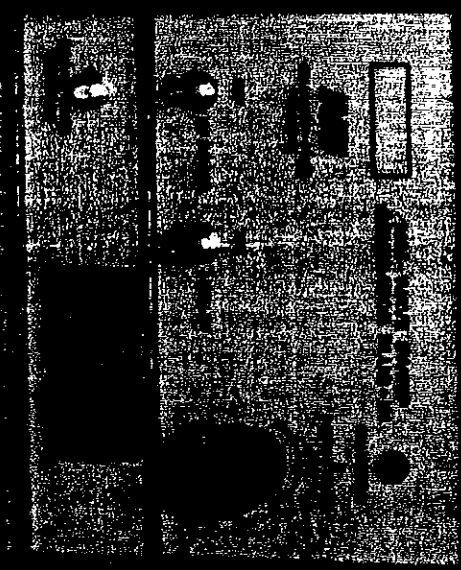
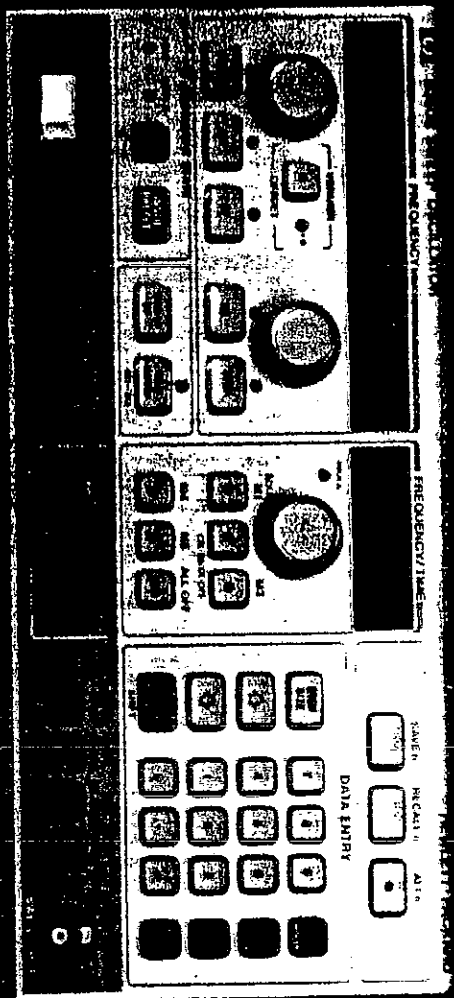
Automatic Noise measurement

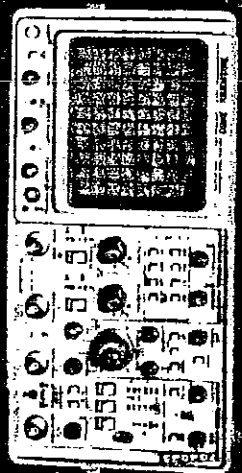
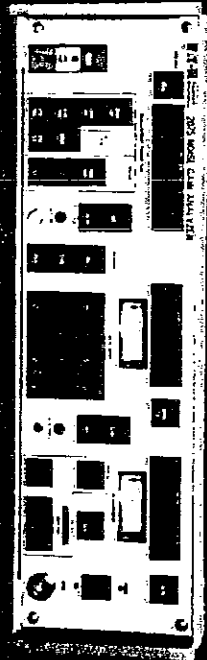
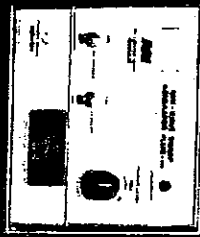
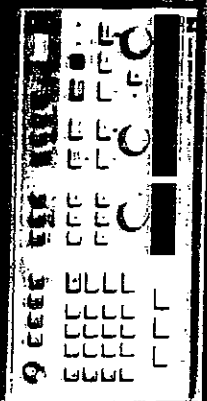
Modular approach



Noise/gain test set block diagram

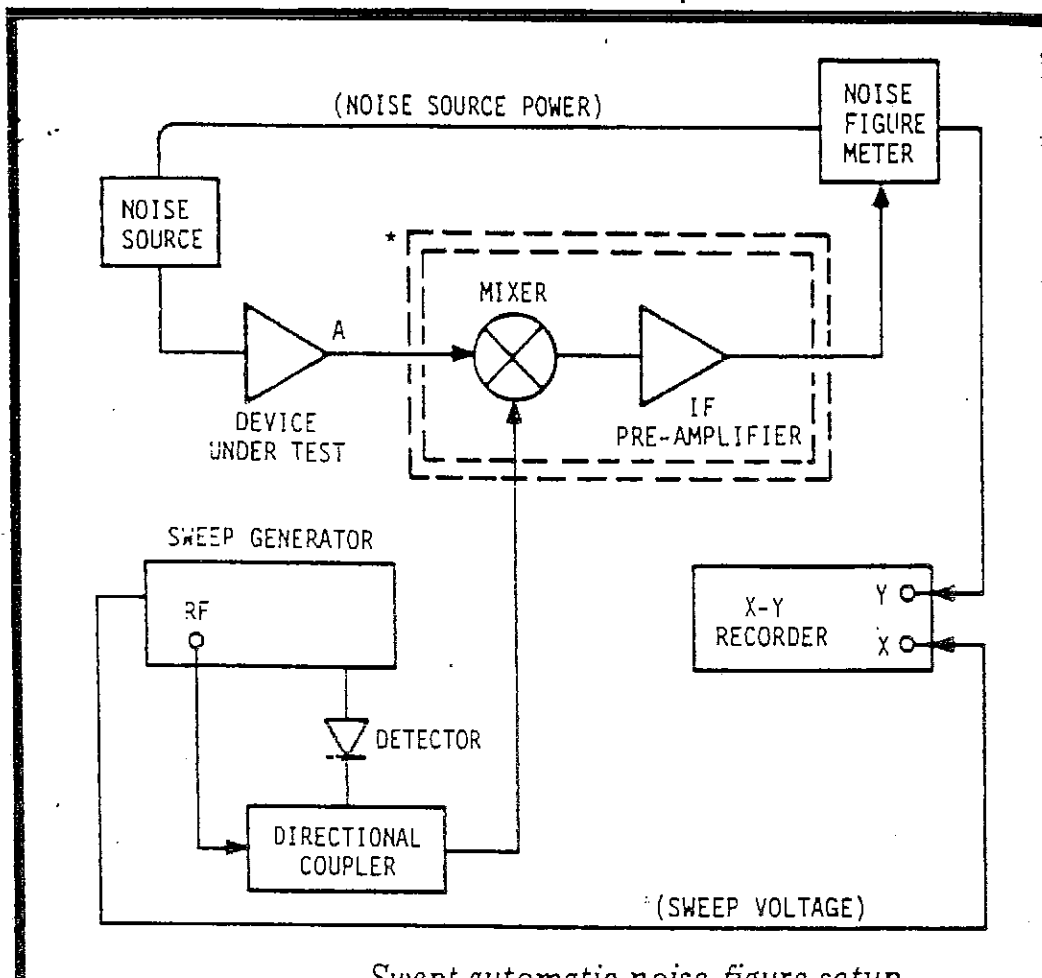






Measurement uncertainties

- 1) Instrumentation uncertainty
 - noise generator ENR accuracy
 - noise figure meter reading accuracy
- 2) mismatch
 - primary (noise generator/DUT)
 - secondary (noise generator/analyser, DUT/analyser)
 - system B.W. mismatch



Swept automatic noise figure setup

3) Image & spurious inaccuracy

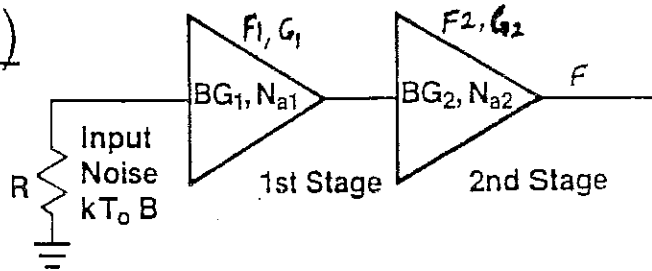
For a broadband noise source:

$$\text{operating NF} = \text{NF (Reading)} + 10 \log (BT/B_{op})$$

4) correction accuracy

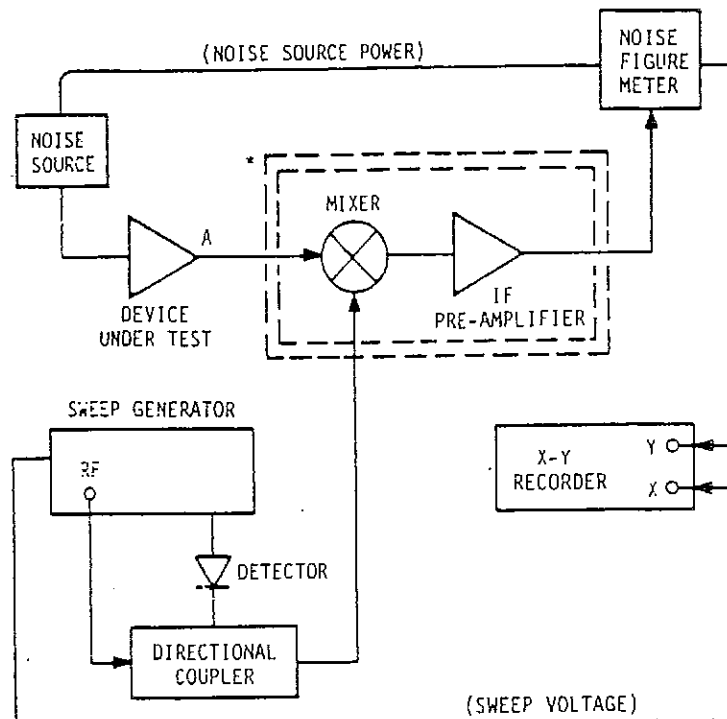
-2nd stage noise contribution

$$F = F1 + \frac{(F2-1)}{G1}$$



5) Poor technique

- Interference
- connector integrity
- consistent connection
- cable loss correction
- DUT linearity



SUMMARY:

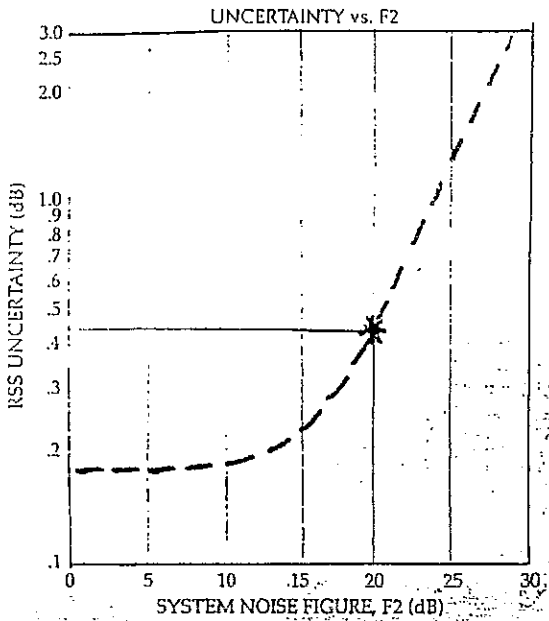


Figure 1. Noise figure measurement uncertainty ($\Delta F1$) vs. measurement system noise figure ($F2$).

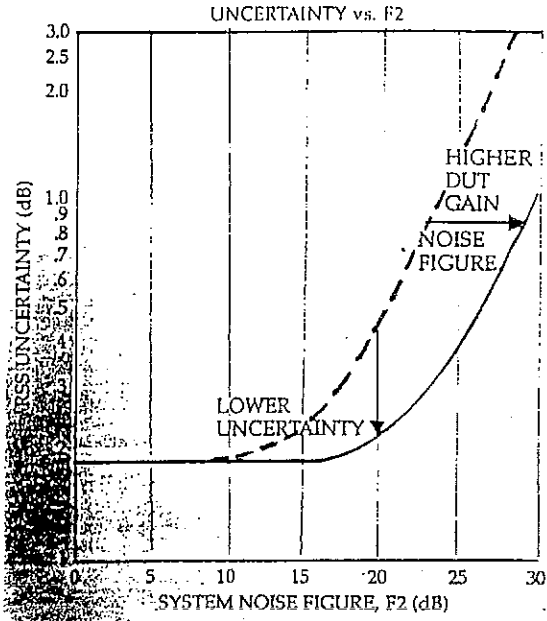


Figure 2. High gain/noise figure DUT shifts curve to right, lower uncertainty results.

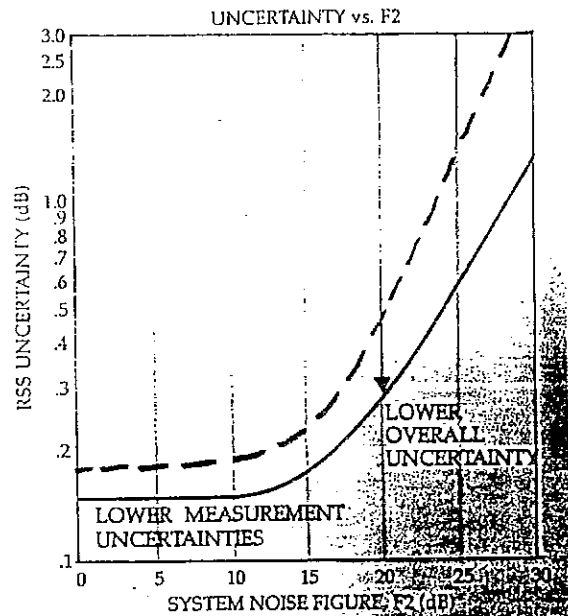


Figure 3. Lowering ENR, mismatch, and instrumentation uncertainties shifts curve down and decreases upward slope, lower overall uncertainty results.

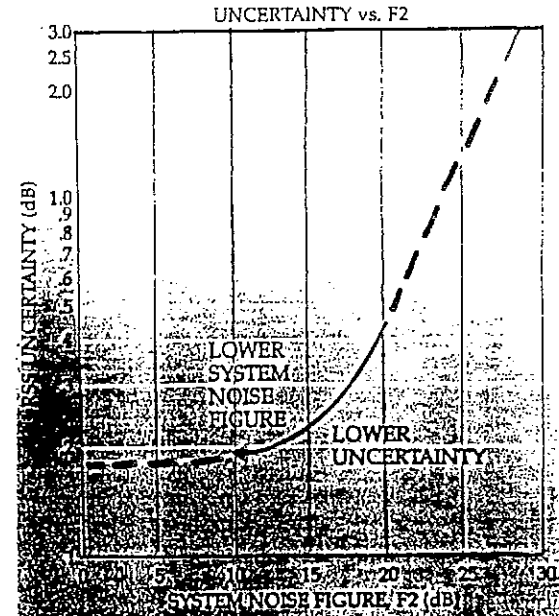


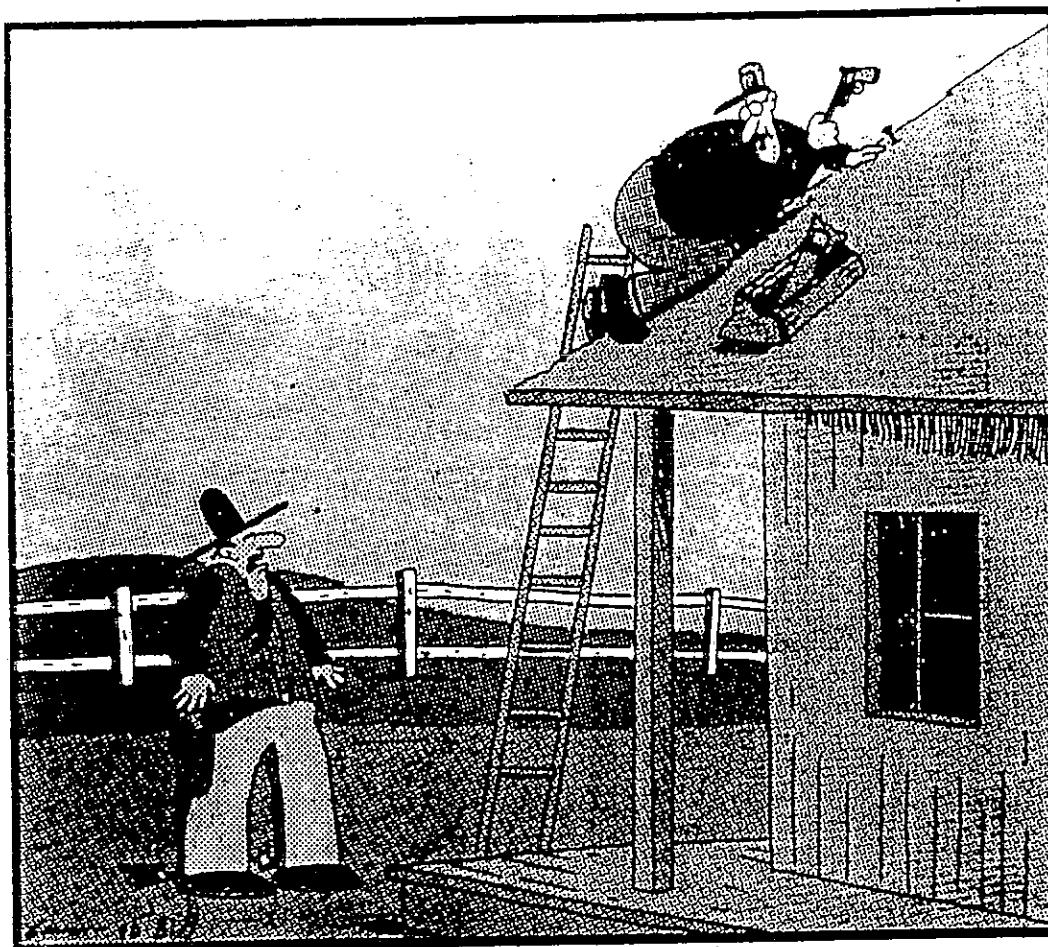
Figure 4. Lowering measurement system noise figure ($F2$) moves uncertainty down along curve, lower uncertainty results.

SUMMARY:

Example of Measurement Uncertainties

	RF		Micro-wave	
Second stage correction uncertainty		0.01 dB		0.10 dB
Second stage noise figure	6 dB		10 dB	
T_c correction uncertainty		0.01		0.01
ENR uncertainty		0.10		0.15
Mismatch uncertainty		0.15		0.15
Source SWR	<1.10		<1.13	
DUT SWR	<1.40		<1.5	
Instrumentation uncertainty		0.10		0.10
Total uncertainty (Root-sum-of-the-squares)		0.21 dB		0.25 dB

CONCLUSION:



"So ... they tell me you're pretty handy with a gun."

